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Surface Radiation Properties of ThO₂
and Other Reactor Materials

by

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ABSTRACT

This technical report summarizes the results obtained on surface radiation properties of ThO₂ and other related reactor materials. The content herein is based on the M.S. dissertation submitted by H.H. Ma, Department of Mechanical Engineering, University of Wisconsin at Milwaukee, December 1979. It is compliment to the previous report - CDO-4040-3, 1978, which summarizes the results of UO₂ and other pertaining materials.

Specifically, the present study provides surface radiation properties of three nuclear reactor materials; thorium dioxide, sodium and steel (99 Fe + 1 C). First, based on transmission spectra and Kramers-Kronig analysis, the complex refractive index, which is fundamental to surface radiation property calculations, of ThO₂ is presented over a wide spectral range. Then depending on the contacting media, three types of the surfaces are considered. They are the interfaces between ThO₂ and Sodium, ThO₂ and Steel (99 Fe + 1 C) as well as ThO₂ and a gas. For each interface, the spectral interface reflectance from one side of the medium to the other side is evaluated for all wavelengths. These spectral properties are further integrated to yield the total hemispherical properties over a temperature range, 1200°K to 6000°K, of interest to reactor safety analysis.

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NOMENCLATURE

I - intensity of radiative flux

k - extinction coefficient

$K_{a\lambda}$ - absorption coefficient

n - real index of refraction

\hat{n} - complex index of refraction ($= n - ik$)

T - temperature

Greek:

α - total absorptance

α_λ - spectral absorptance

ε - total emittance

ε_λ - spectral emittance

ϕ - phase angle

θ - incidence angle

λ - wavelength

ρ - total reflectance

ρ_λ -spectral reflectance

Subscripts:

1 - medium 1

2 - medium 2

i - incident quantity

n - normal direction

s -source

t - transmitting quantity

λ - wavelength

I. INTRODUCTION

In the safety analysis of nuclear reactors, the temperature of the reactor materials involved often is high enough (1200 to 6000°K) that thermal radiative transfer may become an important mode of heat transfer as compared to conduction and convection.¹⁻⁴ To perform radiative transfer calculations, the information on thermal radiation properties of reactor materials is needed. Chan and Tseng⁵ recently presented the surface radiation properties of uranium dioxide when in contact with various reactor media. The present study aims to extend their work to include thorium dioxide. Thorium dioxide has renewed interest as a potential reactor fuel, particularly, in view of recent concern about nuclear proliferation.

To use the well known Fresnel relations to calculate surface radiation properties, the values of the complex refractive index ($\hat{n} = n - ik$) of a substance must be provided. The real part of the index, n , is generally called as the index of refraction and the imaginary part, k , as the extinction coefficient. Since the optical constants of ThO_2 are only known at a few selected wavelengths, their values, as one of major purposes of the present study, will be made available over a wide range of the wavelength spectrum. The method to be employed to calculate these optical constants is Kramers-Kronig (K-K) theory, which is a powerful but relatively unknown to heat transfer engineers. A brief review of the theory seems to be in order.

The theory of Kramers-Kronig analysis of reflectance spectra measured with normal incidence on the plane sample was originally described by Robinson,⁶ in 1952. Then, in 1967, Berreman⁷ extended the applicability of the K-K analysis by presenting an algorithm for computing the phase shifts and n , k from a reflectance spectrum obtained from a radiant flux. The flux was linearly polarized either parallel or perpendicular to the plane of incidence and was specularly reflected at an oblique angle.

In a later work, Didrikil⁸ developed a method of K-K analysis for determining the optical constants from the reflectance spectra at an oblique angle of incidence with complete allowance for the degree of polarization, especially zero polarization. For any non-conductor, increasing the angle of incidence continuously increases the component of spectral reflectance. With nonpolarized light a considerable increase in the reflectance takes place for angles of incidence greater than the Brewster angle. In principle, increasing the incidence angle makes it possible to improve the accuracy of measurement of the reflectance in the case where the reflectance at normal incidence is low.

K-K analysis has the advantage of eliminating the need for a polarizer, and increasing the intensity of the reflected light. K-K analysis can be used for any wavelength range, and is suitable to any non-magnetic material. Thus, it simplifies the experimental equipment required and furnishes a better design for the reflection experiment.

This study will discuss two methods that K-K theory can be applied to determine the optical constants from spectral measurement: one from reflection spectra and the other from transmission spectra. After both methods are tested by the classical Lorentz dispersion model, the optical constants of ThO₂ will be determined, followed by evaluating the radiation properties of three types of interfaces:

- a. ThO₂ in contact with sodium.
- b. ThO₂ in contact with steel.
- c. ThO₂ in contact with water vapor.

For each interface, the spectral hemispherical reflectivity will be determined for all wavelengths of interest and the total hemispherical reflectivity from a black body source over a wide temperature range (1200 - 6000°K).

II. ELECTROMAGNETIC THEORY

To begin with, a brief review of reflection laws, primarily Fresnel's relation, from the electromagnetic theory will be made. They will be employed to calculate radiation properties in latter sections.

Fresnel's equations were derived by Fresnel in 1823. On the basis of the elastic theory of light, they give the ratios of the amplitudes of the incident, reflected, and transmitted waves.

Consider two semi-infinite media in direct contact as shown in Fig. 1. They can be either metals or dielectrics, with complex refractive indices $\hat{n}_{1\lambda}$ and $\hat{n}_{2\lambda}$ respectively. The interface between two media is assumed to be specular and optical smooth. The complex index of refraction is shown by $\hat{n}_\lambda = n_\lambda - ik_\lambda$. The subscript λ denotes that \hat{n}_λ , n_λ and k_λ are, in general, a function of radiation wavelength. According to Fresnel equations, the monochromatic directional reflectance of radiation from medium 1 back to the same medium is

$$\rho_{\lambda II}(\theta) = \frac{1}{2} (\rho_{\lambda IIS}(\theta) + \rho_{\lambda IIP}(\theta)) \quad (II.1)$$

where

$$\rho_{\lambda IIS}(\theta_r) = \left| \frac{\hat{n}_{1\lambda} \cos \theta_i - \hat{n}_{2\lambda} \cos \theta_t}{\hat{n}_{1\lambda} \cos \theta_i + \hat{n}_{2\lambda} \cos \theta_t} \right|^2 \quad (II.2)$$

$$\rho_{\lambda IIP}(\theta_r) = \left| \frac{\hat{n}_{2\lambda} \cos \theta_i - \hat{n}_{1\lambda} \cos \theta_t}{\hat{n}_{2\lambda} \cos \theta_i + \hat{n}_{1\lambda} \cos \theta_t} \right|^2 \quad (II.3)$$

and $\theta_r = \theta_i$. θ_t can be calculated from Snell's law

$$\hat{n}_{2\lambda} \sin \theta_t = \hat{n}_{1\lambda} \sin \theta_i \quad (II.4)$$

In Eq. (II.1), a circularly polarized light has been assumed, i.e. polarization of the light is assumed to be zero. In case the optical constants are known for all the wavelengths, the spectral directional reflectance over all wavelengths can be found. Then, the monochromatic hemispherical reflectance $\rho_{\lambda ll}$ can be determined by integration over the hemisphere,

$$\rho_{\lambda ll} = 2 \int_0^{\frac{\pi}{2}} \rho_{\lambda ll}(\theta) \sin\theta \cos\theta d\theta \quad (\text{II.5})$$

and the total hemispherical reflectance can be calculated by integrating over the wavelength,

$$\rho_{ll}(T_s) = \frac{\int_0^{\infty} \rho_{\lambda ll} H_{\lambda}(T_s) d\lambda}{\int_0^{\infty} H_{\lambda}(T_s) d\lambda} \quad (\text{II.6})$$

In Eq. (II.6) H_{λ} is the incident radiation from a source at temperature T_s . Although the monochromatic reflectance ρ_{λ} is purely a function of the optical properties, the total reflectance ρ is not, as it depends also on the source temperature T_s . In the absence of a better radiating source, we take it as a black body source at $T_s = T_1$. Thus, the Planck's function serves as a weighting factor. Since it shifts to lower wavelengths as temperature T_s increases, ρ_{λ} 's at lower wavelengths are weighted more than those at higher wavelengths. Generally speaking, the temperature T_s has a significant effect on the reflectance. Care should be taken not to use the temperature of medium 2 on the other side of the interface. Strictly speaking, the optical constants are temperature dependent. However, due to the lack of data

at elevated temperature, such temperature dependence could not be accounted for at the present time.

The monochromatic directional transmittance from medium 1 to 2 is given by

$$t_{\lambda 12}(\theta) = 1 - \rho_{\lambda 11}(\theta) \quad (\text{II.7})$$

which is the same as the monochromatic directional absorptance of an incident radiation from medium 1 to medium 2.

$$\alpha_{\lambda 12}(\theta) = t_{\lambda 12}(\theta) \quad (\text{II.8})$$

In accordance with Kirchhoff's law, the directional monochromatic emittance from medium 2 to 1 is

$$\varepsilon_{\lambda 21}(\theta) = \alpha_{\lambda 12}(\theta) \quad (\text{II.9})$$

if $T_1 = T_2$. Therefore, under the condition of a black body source and the condition that $T_2 = T_1$, the total hemispherical properties are inter-related by

$$\rho_{11} = 1 - \alpha_{12} = 1 - \varepsilon_{21} = 1 - t_{12} \quad (\text{II.10})$$

Furthermore, the theory can be simplified under these two special cases. They are cited below.

First, if the medium 1 is a dielectric medium such as air or any other gases or vapors, then $k_1 \approx 0$, $n_1 \approx 1$, and $\hat{n}_1 \approx 1$. Upon the substitution of $\hat{n}_1 \approx 1$ into Eq. (II.2) and (II.3) yields expressions quoted by most textbooks.⁹⁻¹⁰ This is of particular interest to engineers because the measurements of all the surface properties are conducted by placing the specimen in air, vacuum, or some gaseous media.

The other one is the normal reflectance. When the incident radiation is normal to the interface,

$$\theta_i = \theta_r = \theta_t = 0$$

Then, from Eqs. (II.1) to (II.4),

$$P_{\text{alln}} = P_{\text{allp}} = P_{\text{alls}} = \left| \frac{\hat{n}_{2\lambda} - \hat{n}_{1\lambda}}{\hat{n}_{2\lambda} + \hat{n}_{1\lambda}} \right|^2 \quad (\text{II.11})$$

which is indeed simple and useful.

In summary, the electromagnetic theory provides a prediction of the monochromatic specular reflectance, from which the spectral specular transmittance and emittance can be inferred, if necessary. Then, spectral and total hemispherical properties can be evaluated.

III. KRAMERS-KRONIG THEORY FOR THE DETERMINATION OF OPTICAL CONSTANTS

In accordance with K-K theory, there are two methods to extract the values of the fundamental spectroscopic parameters, namely, the optical constants n and k , from spectroscopic measurements. The first method is based on a measured reflection spectrum and the second one based on a measured transmission spectrum. The latter is applicable to gaseous media or semi-transparent solids such as ThO_2 or other dielectric materials while the former to solids only, but irrespectively whether the solid is semi-transparent or not, i.e. applicable to dielectrics as well as metals. Even though the second method will not be used in the present study, both methods for the sake of completeness will be described in detail and tested using the classical Lorentz oscillator model. Then, the first method will be employed to calculate the optical constants of ThO_2 .

III.1 Optical Constants from Reflection Measurement

III.1.1 Working Formula

According to Fresnel relations, the optical constants n and k can be determined from the spectrum of a perpendicular component R_s by means of the following equations:⁸

$$n = \left\{ \frac{(Q^2 - P^2 + \sin^2 \theta) - ((Q^2 - P^2 + \sin^2 \theta)^2 + 4Q^2 P^2)^{\frac{1}{2}}}{2} \right\}^{\frac{1}{2}} \quad (\text{III.1})$$

$$k = PQ/n \quad (\text{III.2})$$

where

$$P = \frac{2\sqrt{R_s} \sin\phi \cos\theta}{1 + R_s - 2\sqrt{R_s} \cos\phi} \quad (\text{III.3})$$

$$Q = \frac{(1 - R_s) \cos\theta}{1 + R_s - 2\sqrt{R_s} \cos\phi} \quad (\text{III.4})$$

and θ is the angle of incidence. Alternatively, P and Q can be expressed in terms of θ , n and k as follows

$$P = nk/Q \quad (\text{III.5})$$

$$Q = \left\{ \frac{(n^2 - k^2 - \sin^2\theta)^2 + (n^2 - k^2 - \sin^2\theta)^2 + 4n^2 k^2}{2} \right\}^{\frac{1}{2}} \quad (\text{III.6})$$

In the above equations, the phase angle ϕ can be determined from the K-K relationship¹¹⁻¹³

$$\phi(a) = -\frac{2a}{\pi} \int_0^\infty \frac{\ln|\sqrt{R_s(\omega)}|}{\omega^2 - a^2} d\omega \quad (\text{III.7})$$

where ω is an angular frequency, a is the resonance frequency. It relates the phase angle ϕ to the perpendicular component of the specular reflectance R_s , and was obtained from a K-K analysis of an absolute, specular reflectance spectrum of a material. A brief derivation of the phase-shift dispersion relation is given in Appendix B.

The integral relation Eq. (III.7) shows that if the perpendicularly polarized reflectivity R_s is measured over the whole frequency spectrum, the phase angle and the indices n and k can be calculated for any arbitrary frequency at a given incident angle. Performing integration by parts, Eq. (III.7) becomes

$$\phi(a) = \pi^{-1} \int_0^\infty \ln \left| \frac{\omega-a}{\omega+a} \right| \frac{d \ln R_s^{\frac{1}{2}}(\omega)}{d\omega} d\omega \quad (\text{III.8})$$

Based on the assumption that the slope of R_s be zero at $\omega=0$ and $\omega=\infty$, we can rewrite Eq. (III.8) into a more convenient form (see Appendix C) as,

$$\phi(a) = \pi^{-1} \sum_{k=2}^{n-1} p_k \left[(a-\omega_k) \ln |a-\omega_k| + (a+\omega_k) \ln |a+\omega_k| \right] \quad (\text{III.9})$$

where

$$p_k = u_{k+1} - u_k$$

and

$$u_k = \frac{\ln R_s^{\frac{1}{2}}(\omega_k) - \ln R_s^{\frac{1}{2}}(\omega_{k-1})}{\omega_k - \omega_{k-1}}$$

The above equation can be easily programmed for numerical computation, a copy of FORTRAN program is given in Appendix E.

By examining Eq. (III.8), we find the values of $R_s(\omega)$ in the spectral regions where $\omega \gg a$ or $\omega \ll a$, do not contribute to the value of $\phi(a)$, because then the weighting function $\ln \left| (\omega-a) / (\omega+a) \right|$ approaches zero. Thus, we can neglect the variations of the reflectance spectrum, even if the variations are reasonably large, in those region. Consequently, we can assume the reflectance flatten out on both ends of spectrum. Moreover, in view that the spectral region in which the reflectance is constant do not contribute to the value of $\phi(a)$, only a finite spectral region of the reflectance spectrum needed to be measured, which reduces experimental efforts considerably.

The reflectance measured in the experiment is not R_s , but is R_o

given by

$$R_o = \frac{1}{2} [R_s(1+\alpha) + R_p(1-\alpha)] \quad (\text{III.10})$$

where α is the degree of polarization

$$\alpha = \frac{I_s - I_p}{I_s + I_p}$$

I_s and I_p are the reflected intensities of light in the planes perpendicular and parallel to the plane of incidence respectively.

We can rewrite Eq. (III.10) in the form

$$R_s = \frac{2R_o}{(1+\alpha) + (R_p/R_s)(1-\alpha)} \quad (\text{III.10.a})$$

Because we are interested in using a nonpolarized light, $\alpha=0$. The ratio R_p/R_s in turn is defined in the terms of P , Q and θ as

$$\frac{R_p}{R_s} = \frac{(Q-\sin\theta\tan\theta)^2 + P^2}{(Q+\sin\theta\tan\theta)^2 + P^2} \quad (\text{III.11})$$

Also,

$$R_s = \frac{(Q-\cos\theta)^2 + P^2}{(Q+\cos\theta)^2 + P^2} \quad (\text{III.11.a})$$

III.1.2 Direct Method

If we can determine the ratio R_p/R_s and knowing the value of polarization α through the experiment, then it is possible to calculate the R_s spectrum directly from the measured reflectance R_o using Eq. (III.10.a). The optical constants can then be calculated from Eqs. (III.1) and (III.2) with P and Q from Eqs. (III.3) and (III.4). However, it is not simple to determine the ratio R_p/R_s because R_s is unknown.

In order to determine the ratio R_p/R_s , experimental setup is somewhat complicated and expensive as the source light has to be polarized. Therefore, this method is avoided whenever possible. Instead the following method is more favorable.

III.1.3 Iterative Method

For the determination of the optical constants from the measured R_o spectrum, we use the method of successive approximations suggested by Ref. 8. We can substitute R_o in place of R_s in Eqs. (III.3), (III.4) and (III.7). The values of $\phi(a)$ obtained are used to calculate the zeroth approximation of P and Q from Eqs. (III.3) and (III.4), and R_p/R_s from Eq. (III.11). Based on the R_p/R_s value, the first approximation of R_s^* is obtained from Eq. (III.10.a) which is then used to redetermine ϕ , P, Q, R_p/R_s and the next approximation of R_s^* until convergence is reached. The final set of R_s^* is the desired R_s . Therefore, this process of successive approximations makes it possible to obtain the R_s spectrum from R_o spectrum with the required degree of accuracy and certain imposed conditions to be discussed later.

In certain wavelength range, sustained oscillations of the values of R_s^* may be produced, so the suggestions made by Ref. 8 can be followed. Since the difference between $R_s^*-R_s$ in the i th and $(i-1)$ th iteration have different signs, we introduce the additional condition

$$R_s^*(i) = \frac{1}{2}[R_s^*(i) + R_s^*(i-1)] \quad (\text{III.12})$$

to expedite the convergence. The above equation means that, in the process of iteration, instead of using the newly obtained R_s^* value from $(i-1)$ th iteration for i th iteration, a weighted average with the previous value should be used. Equation (III.12) is used only for the calculation of

those R_s^* which the corresponding R_o exceed a certain value B . The number of iterations for convergence depends on the choice of B , and increases with an increase in the incidence angle.

For the reflectance with a high maximum of R_o , R_{\max} , and a relatively low edge, the value of B can be taken as $R_{\max}/2$. For spectra with low R_{\max} and a high long wave edge, the lower limit of B can be taken as the value of C , where $C = (R_{ok} + R_{\max})/2$. R_{ok} is the value of the reflectivity of long wave edge at a sufficient distance from the reflection band. In the intermediate case, B has a value lying between $R_{\max}/2$ and C . In practice, it is better not to use Eq. (III.12) in the first iteration. Instead it is applied to all points of the spectrum after 4-6 iterations. Or, simply setting $B=C$ in the first 4-6 cycles, then apply Eq. (III.12) to all the points of R_s^* spectrum.⁸

As to the selection of the angle of incidence θ , we use the value of the normal reflectivity at the maximum of the reflectance band, R_n , as a criterion. For high values of R_n , on the order of 0.9, the use of an oblique incidence angle may prove useful, though it is necessary to restrict the angle of θ not to exceed 60° . For R_n less than the order of 0.1, the angle θ may reach 80° . In the intermediate cases, it is convenient to select θ around 70° .

To test the validity of the iterative method for the determination of R_s and therefore the optical constants from Eqs. (III.1) to (III.5) from R_o spectrum, the classical Lorentz oscillator model is used. Details about the oscillator can be found in Appendix A.

Let us take the oscillator equations which best fit the reflectivity data of the material α -II₂SiC for example. The four correlation parameters in the equations for this material have been found as¹⁴

$$\rho = 0.263$$

$$\tau = 0.006$$

$$\alpha = 12.60$$

$$\varepsilon_0 = 6.7$$

With these parameters, n and k of α -II₂SiC can be calculated from Eqs. (A.17) to (A.21) in Appendix A and the results are listed in the last two columns of Table 1. Also can be calculated are P and Q from Eqs. (III.5) and (III.6), respectively. Finally by choosing a non-polarized light, $\alpha=0$, and an incidence angle of $\theta=60^\circ$ or $\theta=70^\circ$, R_o and R_s reflection spectra can be calculated through the use of Eqs. (III.11) and (III.11.a). They are displayed in Fig. 2 and listed in Table 1 as well.

Using the R_o spectrum and the iterative method as just described, the values of R_s^* , n^* and k^* at the end of the iteration are shown in Table 2 and Figs. 3 and 4. By comparing those in Table 2 with R_s , n and k values in Table 1 or by examining Figs. 3 and 4, we see that, for the case of $\theta=70^\circ$, they are in good agreement everywhere except near the peak region between 11 and 13. The sustained oscillations of R_s^* can not be avoided even if the additional condition, Eq. (III.12), is used. One possible reason is that the incidence angle is too high. If we check the reflectance spectra, there are many reflectance exceed the value of 0.95. In this instance, the incidence angle should be restricted to 60° or less. As we examine the case with $\theta=60^\circ$, we find the results in figs. 3

and 4 not only converge everywhere but also in good agreement through the whole spectrum. Thus the iterative K-K analysis can be successfully applied in determining the optical constants directly from the experimental reflection spectra.

As stated in Ref. 8, it should be mentioned in passing that the magnitude of error depends on the ratio of R_p/R_s . If both polarization α and R_p/R_s are zero, the magnitude of error reaches a maximum. When a nonpolarized light is used in an experiment, α is equal to zero, then the ratio R_p/R_s becomes critical to the accuracy of the iterative method using the K-K analysis.

III.2 Optical Constants from Transmission Measurement

In the thin-film theory, the absorption coefficient, $K_{a\lambda}$, which describes the fractional decrease in intensity I with distance s , is defined as

$$K_{a\lambda} = \frac{1}{I} \frac{dI}{ds} \quad (\text{III.13})$$

Therefore,

$$K_{a\lambda} = \frac{\ln(I_0/I)}{s} = \frac{2.303 \times \text{O.D.}}{s} \quad (\text{III.14})$$

where: I_0 - is the intensity of the light beam before shining onto the sample.

s - sample thickness.

O.D. - optical density.

From the above, $K_{a\lambda}$ can be evaluated from transmission or absorption spectra which describe the optical density as a function of λ . Then one of the optical constants, namely, the extinction coefficient k ,

can be evaluated from $K_{a\lambda}$ by the relation

$$k = K_{a\lambda} \lambda / 4\pi \quad (\text{III.15})$$

To evaluate the other optical constant, the K-K dispersion relations are introduced. They are integral relations between the real and imaginary parts of a function $f(\omega)$ which is frequency dependent, and analytic in the upper half of the complex frequency plane. For a given frequency a , these relations can be written:¹⁵

$$\operatorname{Re} f(a) = \frac{2}{\pi} \operatorname{p.v.} \int_0^{\infty} \frac{\omega \operatorname{Im} f(\omega)}{\omega^2 - a^2} d\omega \quad (\text{III.16})$$

$$\operatorname{Im} f(a) = - \frac{2}{\pi} \operatorname{p.v.} \int_0^{\infty} \frac{\operatorname{Re} f(\omega)}{\omega^2 - a^2} d\omega \quad (\text{III.17})$$

where: p.v. signifies principle value of the integral for $\omega=a$.

These relations are valid for any physical quantity which expresses a linear relation between the response of system and the incident excitation, under the condition that the response of a system could never preceed the incident excitation. These relations are useful if the complex function of $f(\omega)$ is replaced by the complex index, $n(\omega) = n(\omega) - ik(\omega)$. We have,

$$n(a) = \frac{2}{\pi} \operatorname{p.v.} \int_0^{\infty} \frac{\omega k(\omega)}{\omega^2 - a^2} d\omega \quad (\text{III.18})$$

$$k(a) = - \frac{2}{\pi} \operatorname{p.v.} \int_0^{\infty} \frac{n(\omega)}{\omega^2 - a^2} d\omega \quad (\text{III.19})$$

If either $n(\omega)$ or $k(\omega)$ function is known, the other function can be determined directly through one of the integrals. Consequently, we don't really have to measure the reflectances for certain crystals if the transmission spectra are known, because from the transmission spectra the absorption coefficient $K_{a\lambda}$ can be calculated from Eq. (III.14) as a function of frequency. Therefore, the extinction coefficients

can be calculated from Eq. (III.15), and $n(\omega)$ from Eq. (III.18).

Similar to Eq. (III.7), Eqs. (III.16) and (III.17) can be expressed in the following conveniently numerical forms,¹⁵

$$n(a) - n(\infty) = \frac{1}{\pi} \sum_{k=2}^{n-1} q_k \left[(a-\omega_k) \ln |a-\omega_k| - (a+\omega_k) \ln (a+\omega_k) \right] \quad (\text{III.20})$$

$$k(a) = - \frac{1}{\pi} \sum_{k=2}^{n-1} p_k \left[(a-\omega_k) \ln |a-\omega_k| + (a+\omega_k) \ln (a+\omega_k) \right] \quad (\text{III.21})$$

where: ω_k - the frequency of a pole of a partial fraction.

q_k - the variation of the slope of $k(\omega)$ at these points.

p_k - the variation of the slope of $n(\omega)$ at these points. (see Appendix C)

It should be mentioned that any error in the determination of a measured function, even if it occurs only at a single frequency, will affect the whole assembly of the calculated values of the other function. In particular, the inherent assumption of zero slope at both integration limits in Eqs. (III.20) and (III.21) should be carefully observed by setting, for example, $k_1=k_2$ and $k_{n-1}=k_n$ in Eq. (III.20).

Noting that in the calculation of surface radiation properties, the refractive index n is dominant. Therefore, it is better off not to assume n to be constant. Instead a more realistic refractive index function, $n(\lambda)$, which varies with frequency should be used wherever possible. Thus Eq. (III.20) is of particular importance since it can be used to generate n values from k values.

To test Eq. (III.20), the values of the extinction coefficient k of Lorentz model listed in Table 1 are used in the equation to see if the reproduced index of refraction n^* agrees with the original n listed in Table 1. The results are compared in Table 3 and displayed in Fig. 5. It shows that the agreement is remarkably good.

IV. COMPUTATION & RESULT

Being sucessfully verified in the previous section, the K-K theory can now be employed to calculate the optical constants of thorium dioxide. It will then be followed by the calculation of surface radiation properties of thorium dioxide when it is in direct contact with sodium, steel or a gas.

IV.1 Optical Constants of Thorium Dioxide

Theorectically speaking, the optical constants of ThO_2 can be calculated by the equations from the Lorentz theory of dielectric media. However, in practical applications, we find the equations tend to fail for non-monatomic solids as it is difficult to fit data through the equations even if the criteria described in Appendix A.1 are followed. The calculated k values are found to deviate greatly from the experimental absorption spectrum at different temperatures.

a. Extinction Coefficient k:

According to Ref. 16, Bates reported the absorption spectra of a single crystal ThO_2 at room temperature from the wavelength range 2 to 13μ with 0.048 cm sample thickness. Also, he measured sample at high temperature with different annealed gases from 0.2 to 5μ . The extinction coefficient k, therefore, can be determined from the optical density by Eq. (III.14). The absorption spectra are reproduced in three figures in Appendix D.

b. Index of Refraction n:

Once the extinction coefficient is known, the K-K dispersion theory is applied to find the real part of the complex refractive index, namely, the index of refraction n. The difference between $n(\infty)$ and $n(\omega)$ is

first calculated from Eq. (III.20). In order to determine the values of $n(\omega)$, we have to determine the $n(\infty)$ next. As far as $n(\infty)$ is concerned, it is the square root of ϵ_0 (see Eq. (A.13) in Appendix A). Because the value of ϵ_0 for ThO_2 is not available, we have to interpolate the value from other means. Ellis & Lindstrom¹⁷ reported the index of refraction as following: 5893 Å, $n=2.105\pm 0.005$; 5641 Å, $n=2.110\pm 0.005$; 4358 Å, $n=2.135\pm 0.005$. Since the values of the integral term on the right hand side of Eq. (III.20) can be calculated at any of those three wavelengths, $n(\infty)$ can be evaluated from Eq. (III.20). A value of $n(\infty)=2.072$ seems to fit well at all three wavelengths. With this $n(\infty)$ value, $n(\omega)$ at all wavelengths can be readily calculated as shown in Table 4. The results in the table show that the index of refraction varies only slightly with wavelengths.

IV.2 Optical Constants of Sodium & Steel

The Drude model for metals is obtained directly from the Lorentz model simply by setting α equal to zero in Eq. (A.13) and (A.14)

$$n^2 - k^2 = \epsilon_0 - \frac{4\pi Ne^2}{m} \frac{1}{(\omega^2 + \gamma^2)}$$

$$2nk = \frac{4\pi Ne^2}{m} \frac{\gamma}{(\omega^2 + \gamma^2)}$$

a. Sodium

According to Chan and Tseng⁵, $(4\pi Ne^2/m)^{0.5}$ is $8.9 \times 10^{15} \text{ sec}^{-1}$, and the optimum value of γ appears to be $5.142 \times 10^{13} \text{ sec}^{-1}$. They computed the optical constants using the above equations and the results are drafted in Fig. 6 and Table 5 for convenient. The calculated value of the optical constant at $\lambda=0.2\mu$ is replaced by the same value as that at $\lambda=0.25\mu$.

due to obvious error discussed in Ref. 5.

b. Steel

Again in Chan and Tseng's work, the optimal values $(4\pi Ne^2/m)^{0.5}$ and γ of steel are found to be $2.005 \times 10^{16} \text{ sec}^{-1}$ and $8.26 \times 10^{15} \text{ sec}^{-1}$, respectively. The resulting optical constants are shown in Fig. 7 & Table 6.

IV.3 Spectral Hemispherical Reflectance

Knowing the optical constants of the two contacting materials, it is possible to calculate the spectral hemispherical properties from Eqs. (II.1) to (II.5). The 20-point Gaussian Quadrature is used to integrate Eq. (II.5) to yield the spectral hemispherical reflectance. A sample FORTRAN program is presented in Appendix F.

IV.4 Total Hemispherical Properties

The total hemispherical properties can be calculated from the spectral hemispherical properties by Eqs. (II.6) to (II.10). The trapezoidal method with 44 integration points between 0.2 and 10 is used to evaluate the spectral integral in the equations with a black source temperature ranging from 1200°K to 6000°K .

IV.5 Summary

In general, the radiation properties from the medium 1 side are different from the medium 2 side. It is necessary to indicate from which medium the radiation originates and to which medium it ends up.

In this study we always choose to originate from medium 1 to 2 (subscript "12"). By Kirchhoff's law the spectral absorptance α_{12} equals the spectral hemispherical emittance from medium 2, ϵ_{21} . Since we take the radiation source as a black body at the same temperature as both media in contact, the total hemispherical absorption α_{12} is equal to the total hemispherical emittance ϵ_{21} .

IV.5.1 ThO₂-Sodium Interface (medium 1-ThO₂, medium 2-Sodium)

In reactor safety analysis, it often concerns with the interaction between a molten fuel and a reactor coolant. When a molten ThO₂ drops into a liquid sodium, direct contact occurs and the radiation properties at the ThO₂-sodium interface will be needed for calculating radiative cooling from ThO₂. The calculated spectral hemispherical properties of this interface are given in Table 7 and Fig. 9 while the total hemispherical properties of the interface are given in Table 8 and Fig. 10.

IV.5.2 ThO₂-Steel Interface (medium 1-ThO₂, medium 2-Steel)

When a molten ThO₂ is in direct contact with a reactor material such as stainless steel, the properties of ThO₂-Steel interface would be of interest. Since the optical constants available are for the steel (99Fe + 1C) but not for the stainless steel, we can only calculate the properties of ThO₂-Steel (99Fe + 1C) interface. The spectral hemispherical properties of the contact interface are given in Table 9 and Fig. 11 while the total hemispherical properties of the interface are given in Table 10 and Fig. 12.

IV.5.3 Gas-ThO₂ Interface (medium 1-Gas, medium 2-ThO₂)

This interface exists when a vapor film (or any gas film) separates ThO₂ from sodium or water. The spectral hemispherical properties of such an interface are given in Table 11 and Fig. 13 while the total hemispherical properties of the interface given in Table 12 and Fig. 14.

V. COMPARISON & DISCUSSION

The optical constant of thorium dioxide and the radiation properties of three types of interfaces, namely, ThO_2 -Sodium, ThO_2 -Steel and Gas- ThO_2 , have been calculated in the last section. A number of issues concerning those properties will be discussed here, and a comparison of the results will be made with experimental data or other analytical results that are currently available.

V.1 ThO_2 -Sodium Radiation Properties

As for the total hemispherical reflectance of ThO_2 -Sodium, our calculation (see Fig. 10) shows that it lies in the range of 0.9766 to 0.9903 as the temperature increases from 1200°K to 6000°K . From Table 7, it is clear that the spectral hemispherical values may not be accurate at extremely short wavelengths, say $\lambda \leq 0.2\mu$ due to the inherent error in the optical constants of sodium (see Table 5). Fortunately, the possible error has practically no effect on total radiation property calculations because less than 0.5% of black body radiation energy lies in the region $\lambda \leq 0.2\mu$ even if the black body is at a temperature as high as 6000°K . No results are available for comparison, nor any experimental data are available since a direct measurement of, say, reflection from an interface is possible only when one side of the interface is vacuum or a gas.

V.2 ThO_2 -Steel Radiation Properties

From the analysis, we report the values of spectral and total hemispherical reflectance of ThO_2 -Steel interface in Table 9 & 10, respectively. Because the spectral hemispherical reflectance in the long wavelength region weights more in Eq. (II.6) as temperature increases, the total hemispherical reflectance increases with temperature. Again no comparison can be made in this case.

V.3 Gas- ThO_2 Radiation Properties

1) Spectral Hemispherical Properties

We report that the value of the reflectance is essentially constant, 0.174. Since the index of refraction is dominant in determining the radiation properties and the indices of refraction of both the interfaces change very little ($n_1 = 1$, $n_2 = 2.11$), a constant value is therefore expected. Some experimental values of normal spectral emissivity of thorium dioxide (thoria) were reported in connection with early works on thoria cathodes emission about thirty years ago. They vary over a wide range such as 0.35,²² 0.2 to 0.7²³ at $\mu=0.65$ while 0.35 was also assumed by Ref. 24 to determine thoria surface temperature from pyrometer measurements. Those values, nevertheless, can not be used for comparison with the present analytical calculations because they are the spectral emissivity from a thin coat of thoria on molybdenum²², tungsten²³ or tantalum.²⁴ Since the coating thickness is only 0.025 to 0.038 mm²², 0.05 mm²³ or 0.1 mm²⁴ and the extinction coefficient of thoria is about 26 cm^{-1} , the thoria coating is obviously in the optically thin region that

the radiation from the base metal penetrates through the coating. Therefore, the reported spectral emissivities do not represent that of a bulk thoria.

2) Total Hemispherical Properties

We integrate the spectral hemispherical reflectance of Gas-Th₀₂ interface to obtain the total hemispherical reflectance from 1200°K to 6000°K, and find 0.1741 at 1200°K; 0.1750 at 6000°K (see Fig. 14). Again in connection with the investigations on thoria-coated cathodes,²⁴ total normal emissivity was reported as 0.5 with a thoria thickness of 0.5 mm at 1900°K. Reference 25 claimed between 0.2 to 0.6 in the temperature range of 250 to 800°C for a sintered thoria with an unspecified thickness. Though comparison with the present calculation, which is valid for a pure bulk thoria with an optically smooth surface, may not meaningful for the same reason stated above, it may be appropriate to point out that the total normal reflectivity calculated from Eq. (II.11) is about 0.13 which would lead to a total normal emissivity of 0.87, higher than either reported values. Also should be pointed out is the inherent limitation imposed on the present calculation, namely, the optical constants used were derived from low temperature data (mainly the room temperature) as no higher temperature data are available. Thus the temperature dependence of optical constants can not be accounted for in the present investigation.

VI. CONCLUSION

The present study continues Chan and Tseng's work⁵ in providing the surface radiation properties of reactor materials that are useful in the safety analysis of nuclear reactors. Two methods of using K-K theory to calculate the optical constants from measured reflection and transmission spectra have been put into practical use. In particular, the optical constants of thorium dioxide have been calculated and presented here. Also presented are the spectral and total hemispherical properties of thorium dioxide in contacting with sodium steel or a gas. The spectral hemispherical properties are presented over a wide spectral range while the total hemispherical properties over a temperature range of 1200°K to 6000°K.

Table 1
Reflectance Spectra of the Classical Dispersion for $\alpha=0$

λ (μ)	Wavelength Reflectance in Perpendicular Direction		Experimental Reflectance		Index of Refraction n	Extinction Coefficient k
	R_s $\theta = 60^\circ$	R_s $\theta = 70^\circ$	R_o $\theta = 60^\circ$	R_o $\theta = 70^\circ$		
2.0	0.4326	0.5625	0.2282	0.2816	2.572	0.0
3.0	0.4290	0.5592	0.2259	0.2801	2.550	0.0
4.0	0.4233	0.5541	0.2222	0.2777	2.516	0.0
5.0	0.4148	0.5463	0.2167	0.2742	2.466	0.00035
6.0	0.4019	0.5345	0.2087	0.2689	2.394	0.00073
7.0	0.3815	0.5155	0.1963	0.2607	2.286	0.00155
8.0	0.3460	0.4816	0.1757	0.2465	2.114	0.00337
9.0	0.2705	0.4054	0.1353	0.2156	1.805	0.00834
10.0	0.0082	0.0280	0.0049	0.0209	1.038	0.03485
10.5	0.9472	0.9650	0.9120	0.9377	0.068	0.90216
11.0	0.9781	0.9852	0.9556	0.9620	0.059	1.972
11.5	0.9847	0.9896	0.9658	0.9658	0.078	2.865
12.0	0.9856	0.9901	0.9659	0.9612	0.196	5.046
12.2	0.9842	0.9892	0.9623	0.9552	0.350	6.526
12.4	0.9800	0.9863	0.9517	0.9404	0.958	9.612
12.6	0.9412	0.9594	0.8631	0.8310	16.70	16.49
12.8	0.8273	0.8784	0.6471	0.6016	10.51	0.9323
13.0	0.7727	0.8382	0.5631	0.5242	7.801	0.3325
14.0	0.6600	0.7524	0.4214	0.4106	4.907	0.0503
15.0	0.6157	0.7174	0.3754	0.3777	4.234	0.0227

Table 2
Optical Constants by K-K Theory Using Iterative Method

Wavelength λ (μ)	R_s^*		n^*		k^*	
	$\theta = 60^\circ; \theta = 70^\circ$					
2.0	0.4325	0.5624	2.571	2.571	0.0212	0.0188
3.0	0.4290	0.5592	2.550	2.550	0.0217	0.0183
4.0	0.4233	0.5540	2.516	2.515	0.0254	0.0216
5.0	0.4147	0.5463	2.465	2.466	0.0288	0.0233
6.0	0.4019	0.5344	2.394	2.393	0.0276	0.0204
7.0	0.3815	0.5155	2.285	2.285	0.0389	0.0309
8.0	0.3460	0.4816	2.113	2.113	0.0384	0.0297
9.0	0.2704	0.4053	1.804	1.804	0.0287	0.0204
10.0	0.0080	0.0272	1.012	1.017	0.0457	0.0430
10.5	0.9469	0.9648	0.068	0.068	0.8680	0.8794
11.0	0.9779	*	0.056	*	1.898	*
11.5	0.9845	0.9896	0.086	0.087	3.176	3.156
12.0	0.9854	*	0.169	*	4.649	*
12.5	0.9734	*	1.741	*	11.158	*
12.6	0.9411	*	8.597	*	14.438	*
12.7	0.8707	0.9078	12.195	7.269	5.250	7.031
12.8	0.8272	0.8771	9.860	8.234	2.659	4.256
13.0	0.7726	0.8372	7.569	7.120	1.342	2.018
13.5	0.6998	0.7826	5.602	5.509	0.660	0.8934
14.0	0.6599	0.7515	4.858	4.808	0.4713	0.6368
15.0	0.6155	0.7166	4.189	4.171	0.4044	0.4394

* divergence

Table 3
 Index of Refraction from the Values of Extinction Coefficient
 by Integral K-K Dispersion Relations

Wavelength λ (μ)	Index of Refraction from K-K Analysis n^*	Index of Refraction n	Extinction Coefficient k
5.0	2.516	2.466	0.00035
6.0	2.441	2.394	0.00073
7.0	2.331	2.286	0.00155
8.0	2.156	2.114	0.00337
9.0	1.842	1.805	0.00834
10.0	1.046	1.038	0.03485
11.0	0.0853	0.059	1.972
12.0	0.1760	0.196	5.046
12.1	0.2216	0.254	5.686
12.2	0.3010	0.350	6.526
12.3	0.4604	0.532	7.713
12.4	0.8756	0.958	9.612
12.5	3.419	2.592	13.412
12.6	12.323	16.70	16.495
12.7	15.590	14.04	2.498
12.8	11.001	10.51	0.9323
12.9	9.086	8.815	0.5115
13.0	7.979	7.801	0.3325
14.0	4.996	5.684	0.0503
15.0	4.307	4.234	0.0227
16.0	3.989	3.924	0.0138

Table 4
Optical Constants of ThO₂

Wavelength λ (μ)	Index of Refraction n	Extinction Coefficient k
0.20	2.118	0.0003053
0.25	2.117	0.0001717
0.30	2.116	0.0001694
0.35	2.116	0.0001376
0.40	2.115	0.0001374
0.45	2.114	0.0001168
0.50	2.114	0.0001202
0.55	2.114	0.0001322
0.60	2.113	0.0001488
0.65	2.113	0.0001637
0.70	2.113	0.0001736
0.75	2.112	0.0001717
0.80	2.112	0.0001526
0.85	2.112	0.0001297
0.90	2.112	0.0001030
0.95	2.111	0.0000906
1.00	2.111	0.0000763
1.05	2.111	0.0000641
1.10	2.111	0.0000545
1.15	2.111	0.0000482
1.20	2.111	0.0000458
1.25	2.111	0.0000452

Table 4 (Cont'd)

Wavelength λ (μ)	Index of Refraction n	Extinction Coefficient k
1.30	2.111	0.0000446
1.35	2.111	0.0000436
1.40	2.111	0.0000427
1.45	2.110	0.0000385
1.50	2.110	0.0000343
2.00	2.108	0.0000191
2.50	2.107	0.0000275
3.00	2.107	0.0000435
3.50	2.106	0.0000372
4.00	2.105	0.0000305
4.50	2.105	0.0000326
5.00	2.104	0.0000471
5.50	2.104	0.0000242
6.00	2.103	0.0000092
6.50	2.103	0.0
7.00	2.102	0.0
7.50	2.102	0.0
8.00	2.101	0.0000519
8.50	2.100	0.00026
9.00	2.099	0.000515
9.50	2.099	0.002624
10.00	2.099	0.003513

Table 5
Optical Constants of Sodium

Wavelength λ (μ)	Index of Refraction <i>n</i>		Extinction Coefficient <i>k</i>	
	Present	References	Present	References
0.20	0.007		0.008	
0.25	0.007	0.025*(18)	0.646	0.585*(18)
0.30	0.008	0.036*(18)	1.020	0.944*(18)
0.35	0.009	0.043*(18)	1.333	1.319*(18)
0.40	0.012	0.047*(18)	1.621	1.545*(18)
0.45	0.014	0.045*(18) 0.058*(19)	1.895	1.866*(18) 1.864*(19)
0.50	0.017	0.036*(18) 0.060(19)	2.177	2.102*(18) 2.092*(19)
0.55	0.021	0.052*(19) 0.047*(20)	2.420	2.229*(19) 2.238*(20)
0.60	0.024	0.045*(19)	2.676	2.476*(19)
0.65	0.029	0.049*(19)	2.929	2.733*(19)
0.70	0.033		3.180	
0.75	0.038		3.429	
0.80	0.043		3.676	
0.85	0.048		3.922	
0.90	0.054		4.167	
0.95	0.062		4.265	
1.00	0.066		4.656	
1.05	0.070		4.899	
1.10	0.080		5.141	
1.15	0.087		5.384	
1.20	0.094		5.626	
1.25	0.102		5.868	
1.30	0.111		6.110	

Table 5 (Cont'd)

Wavelength λ (μ)	Index of Refraction n		Extinction Coefficient k	
	Present	References	Present	References
1.35	0.119		6.351	
1.40	0.128		6.591	
1.45	0.138		6.833	
1.50	0.147		7.074	
2.00	0.261		9.474	
2.25		0.410(18)		11.60(18)
2.50	0.407	0.500(18)	11.855	12.50(18)
3.0	0.585	0.610(18)	14.261	14.70(18)
3.5	0.795	0.810(18)	16.655	17.20(18)
4.0	1.038	1.020(18)	19.049	19.40(18)
4.5	1.260		22.355	
4.75		1.71 (18)		22.30(18)
5.0	1.621		23.843	
5.5	1.961		26.251	
6.0	2.331		28.648	
6.5	2.734		31.056	
7.0	3.169		33.468	
7.2		3.66 (18)		32.9 (18)
7.5	3.636		35.881	
8.0	4.134		38.305	
8.5	4.633		40.731	
9.0	5.223		43.162	
9.5	5.815		45.599	
10.0	6.437		48.041	

Table 6
Optical Constants of Steel (99 Fe + 1 C)

Wavelength λ (μ)	Index of Refraction n		Extinction Coefficient k	
	Present	References	Present	References
0.20	0.806		1.626	
0.25	1.048	1.353*(18)	1.963	1.818*(18)
0.30	1.281	1.397*(18)	2.237	2.008*(18)
0.35	1.501	1.472*(18)	2.466	2.357*(18)
0.40	1.707	1.680*(18)	2.666	2.721*(18)
0.45	1.898	1.895*(18)	2.842	2.927*(18)
0.50	2.078	2.130*(18)	3.001	3.109*(18)
0.55	2.246	2.327*(18)	3.149	3.261*(18)
0.60	2.405	2.490*(18)	3.286	3.337*(18)
0.65	2.555	2.615*(18)	3.414	3.434*(18)
0.70	2.700	2.700(18)	3.537	3.537(18)
0.75	2.834		3.651	
0.80	2.964		3.762	
0.85	3.089		3.868	
0.90	3.210		3.971	
0.95	3.326		4.070	
1.00	3.438		4.167	
1.05	3.547		4.261	
1.10	3.653		4.352	
1.15	3.755		4.441	
1.20	3.855		4.528	
1.25	3.953		4.613	
1.30	4.047		4.696	

Table 6 (Cont'd)

Wavelength λ (μ)	Index of Refraction n		Extinction Coefficient k	
	Present	References	Present	References
1.35	4.140		4.778	
1.40	4.231		4.858	
1.45	4.320		4.937	
1.50	4.456		5.073	
2.00	5.200		5.723	
2.50	5.880		6.356	
3.00	6.494		6.929	
3.50	7.049		7.452	
4.00	7.566		7.943	
4.50	8.049		8.405	
5.00	8.505		8.843	
5.50	8.937		9.260	
6.00	9.350		9.659	
6.50	9.745		10.042	
7.00	10.125		10.410	
7.50	10.491		10.766	
8.00	10.844		11.111	
8.50	11.186		11.446	
9.00	11.518		11.771	
9.50	11.841		12.086	
10.00	12.155		12.395	

* Interpolated Values.

Table 7
 ThO₂-Sodium Interface Spectral Hemispherical
 Properties (medium 1-ThO₂; medium 2-Sodium)

Wavelength λ (μ)	$\alpha_{\lambda 12}$	$\rho_{\lambda 11}$
0.20	0.48338	0.51662
0.25	0.00559	0.99441
0.30	0.00731	0.99269
0.35	0.00816	0.99183
0.40	0.01031	0.98969
0.45	0.01116	0.98884
0.50	0.01237	0.98763
0.55	0.01403	0.98597
0.60	0.01464	0.98536
0.65	0.01613	0.98387
0.70	0.01675	0.98325
0.75	0.01763	0.98237
0.80	0.01827	0.98173
0.85	0.01872	0.98128
0.90	0.01937	0.98063
0.95	0.02149	0.97851
1.00	0.02020	0.97980
1.05	0.01988	0.98012
1.10	0.02112	0.97888
1.15	0.02140	0.97860
1.20	0.02159	0.97841

Table 7 (Cont'd)

Wavelength λ (μ)	$\alpha_{\lambda 12}$	$P_{\lambda 11}$
1.25	0.02193	0.97807
1.30	0.02237	0.97763
1.35	0.02253	0.97747
1.40	0.02282	0.97718
1.45	0.02317	0.97683
1.50	0.02330	0.97670
2.00	0.02504	0.97496
2.50	0.02616	0.97384
3.00	0.02683	0.97317
3.50	0.02731	0.97269
4.00	0.02768	0.97232
4.50	0.02488	0.97512
5.00	0.02819	0.97191
5.50	0.02835	0.97165
6.00	0.02847	0.97153
6.50	0.02853	0.97147
7.00	0.02857	0.97143
7.50	0.02861	0.97139
8.00	0.02861	0.97139
8.50	0.02843	0.97157
9.00	0.02859	0.97141
9.50	0.02877	0.97123
10.00	0.02878	0.97122

Table 8

ThO₂-Sodium Interface Total Hemispherical
Properties (medium 1-ThO₂ ; medium 2-Sodium)

Temperature (°K)	α_{12}	P_{11}
1200	0.02337	0.97663
1400	0.02239	0.97761
1600	0.02145	0.97855
1800	0.02054	0.97946
2000	0.01967	0.98033
2200	0.01884	0.98116
2400	0.01804	0.98196
2600	0.01729	0.98271
2800	0.01658	0.98342
3000	0.01591	0.98409
3200	0.01527	0.98473
3400	0.01468	0.98532
3600	0.01412	0.98588
3800	0.01360	0.98640
4000	0.01312	0.98688
4200	0.01266	0.98734
4400	0.01223	0.98777
4600	0.01183	0.98817
4800	0.01146	0.98854
5000	0.01111	0.98889
5400	0.01049	0.98951
5800	0.00994	0.99006
6000	0.00970	0.99030

Table 9
 ThO₂-Steel Interface Spectral Hemispherical
 Properties (medium 1-ThO₂; medium 2-Steel)

Wavelength λ (μ)	$\alpha_{\gamma 12}$	$\rho_{\gamma 11}$
0.20	0.48194	0.51806
0.25	0.53290	0.46710
0.30	0.56324	0.43676
0.35	0.58165	0.41835
0.40	0.59233	0.40767
0.45	0.59815	0.40185
0.50	0.60107	0.39893
0.55	0.60152	0.39848
0.60	0.60061	0.39939
0.65	0.59880	0.40120
0.70	0.59627	0.40373
0.75	0.59320	0.40680
0.80	0.58981	0.41019
0.85	0.58620	0.41380
0.90	0.58256	0.41744
0.95	0.57867	0.42133
1.00	0.57473	0.42527
1.05	0.57083	0.42917
1.10	0.56698	0.43302
1.15	0.56310	0.43690
1.20	0.55927	0.44073
1.25	0.55551	0.44449

Table 9 (Cont'd)

Wavelength λ (μ)	$\alpha_{\gamma 12}$	$P_{\gamma 11}$
1.30	0.55177	0.44823
1.35	0.54806	0.45194
1.40	0.54445	0.45555
1.45	0.54074	0.45926
1.50	0.53419	0.46581
2.00	0.50549	0.49451
2.50	0.47873	0.52127
3.00	0.45646	0.54354
3.50	0.43748	0.56252
4.00	0.42087	0.57913
4.50	0.40637	0.59363
5.00	0.39335	0.60665
5.50	0.38177	0.61823
6.00	0.37117	0.62883
6.50	0.36162	0.63838
7.00	0.35278	0.64722
7.50	0.34472	0.65528
8.00	0.33715	0.66285
8.50	0.33011	0.66989
9.00	0.32355	0.67645
9.50	0.31778	0.68222
10.00	0.31217	0.68783

Table 10

ThO_2 -Steel Interface Total Hemispherical
Properties (medium 1- ThO_2 ; medium 2-Steel)

Temperature (°K)	α_{12}	P_{11}
1200	0.52343	0.47657
1400	0.54060	0.45940
1600	0.55386	0.44614
1800	0.56392	0.43608
2000	0.57138	0.42862
2200	0.57680	0.42320
2400	0.58059	0.41941
2600	0.58308	0.41692
2800	0.58452	0.41548
3000	0.58512	0.41488
3200	0.58502	0.41498
3400	0.58432	0.41568
3600	0.58321	0.41679
3800	0.58169	0.41831
4000	0.57985	0.42015
4200	0.57776	0.42224
4400	0.57546	0.42454
4600	0.57302	0.42698
4800	0.57047	0.42953
5000	0.56784	0.43216
5400	0.56248	0.43752
5800	0.55712	0.44288
6000	0.55449	0.44551

Table 11
 Gas-ThO₂ Interface Spectral Hemispherical
 Properties (medium 1-Gas ; medium 2-ThO₂)

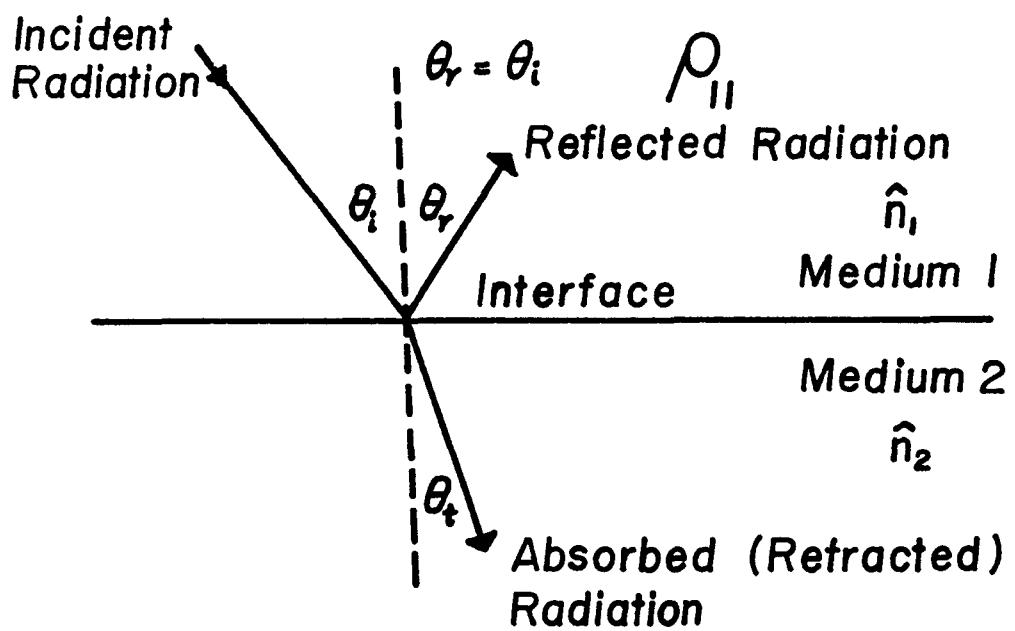
Wavelength λ (μ)	α_{212}	ρ_{211}
0.20	0.82430	0.17570
0.25	0.82442	0.17558
0.30	0.82455	0.17545
0.35	0.82455	0.17545
0.40	0.82468	0.17532
0.45	0.82480	0.17520
0.50	0.82480	0.17520
0.55	0.82480	0.17520
0.60	0.82493	0.17507
0.65	0.82493	0.17503
0.70	0.82493	0.17503
0.75	0.82506	0.17494
0.80	0.82506	0.17404
0.85	0.82506	0.17404
0.90	0.82506	0.17404
0.95	0.82518	0.17482
1.00	0.82518	0.17482
1.05	0.82518	0.17482
1.10	0.82518	0.17482
1.15	0.82518	0.17482
1.20	0.82518	0.17482
1.25	0.82518	0.17482

Table 11 (Cont'd)

Wavelength λ (μ)	$\alpha_{\lambda 12}$	$P_{\lambda 11}$
1.30	0.82518	0.17482
1.35	0.82518	0.17482
1.40	0.82518	0.17482
1.45	0.82531	0.17469
1.50	0.82531	0.17469
2.00	0.82556	0.17444
2.50	0.82569	0.17431
3.00	0.82569	0.17431
3.50	0.82582	0.17418
4.00	0.82594	0.17406
4.50	0.82594	0.17406
5.00	0.82607	0.17393
5.50	0.82607	0.17393
6.00	0.82620	0.17380
6.50	0.82620	0.17380
7.00	0.82632	0.17368
7.50	0.82632	0.17368
8.00	0.82645	0.17355
8.50	0.82658	0.17342
9.00	0.82670	0.17330
9.50	0.82670	0.17330
10.00	0.82670	0.17330

Table 12
 Gas-ThO₂ Interface Total Hemispherical
 Properties (medium 1-Gas ; medium 2-ThO₂)

Temperature (°K)	α_{12}	ρ_{11}
1200	0.82588	0.17412
1400	0.82578	0.17422
1600	0.82570	0.17430
1800	0.82563	0.17437
2000	0.82556	0.17444
2200	0.82551	0.17449
2400	0.82546	0.17454
2600	0.82542	0.17458
2800	0.82538	0.17462
3000	0.82534	0.17466
3200	0.82531	0.17469
3400	0.82527	0.17473
3600	0.82524	0.17476
3800	0.82522	0.17478
4000	0.82519	0.17481
4200	0.82517	0.17483
4400	0.82514	0.17486
4600	0.82512	0.17488
4800	0.82510	0.17490
5000	0.82508	0.17492
5400	0.82504	0.17496
5800	0.82500	0.17500
6000	0.82499	0.17501



$$\alpha_{12} = 1 - \rho_{II}$$

Fig. 1 Incident, reflected and refracted radiation at Interface

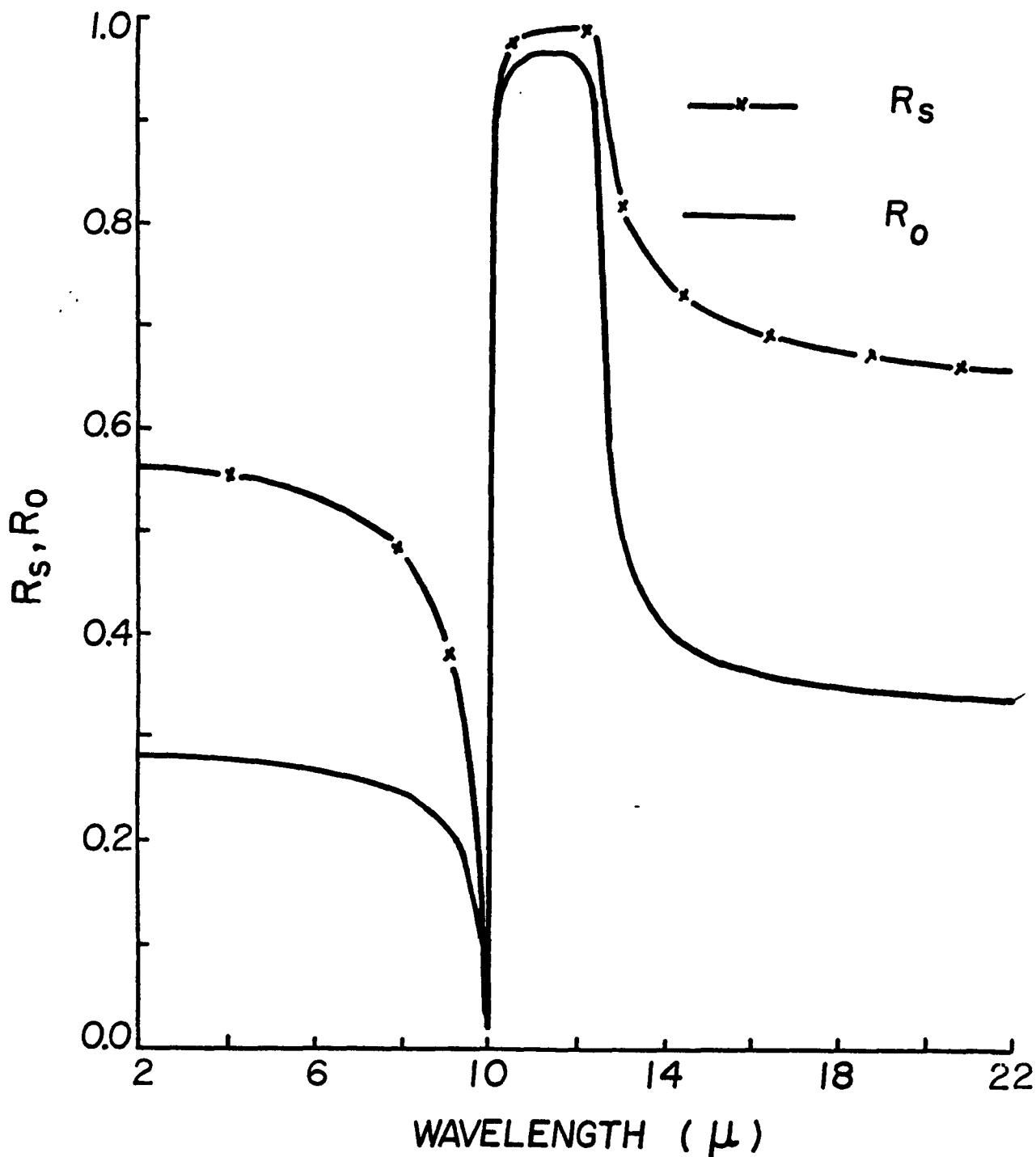


Fig. 2 Reflectance spectra of the Lorentz oscillator for the incidence angle $\theta = 70^\circ$; polarization $\alpha = 0$.

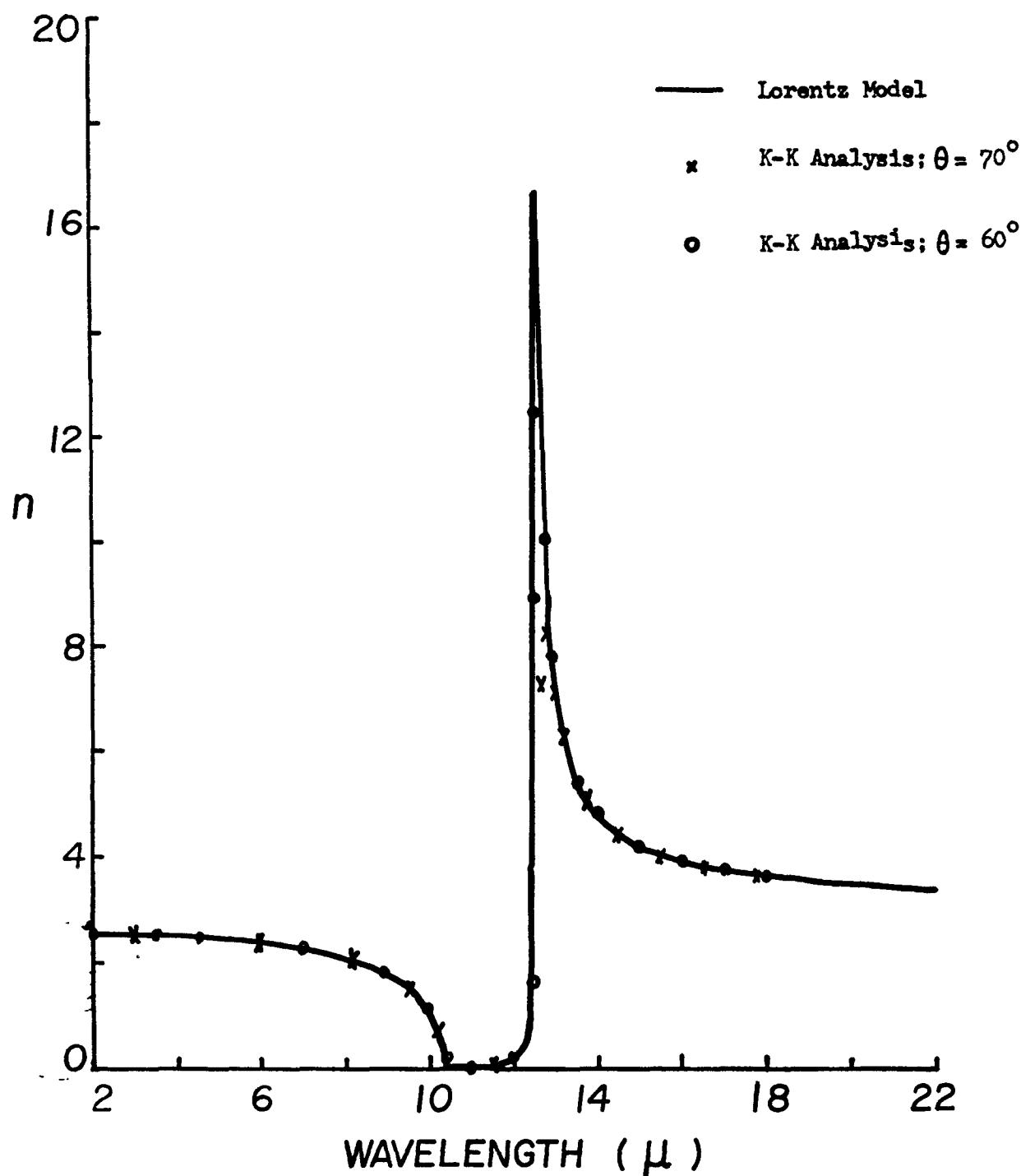


Fig. 3 Index of Refraction by Iterative K-K analysis compare with the values from Lorentz oscillator.

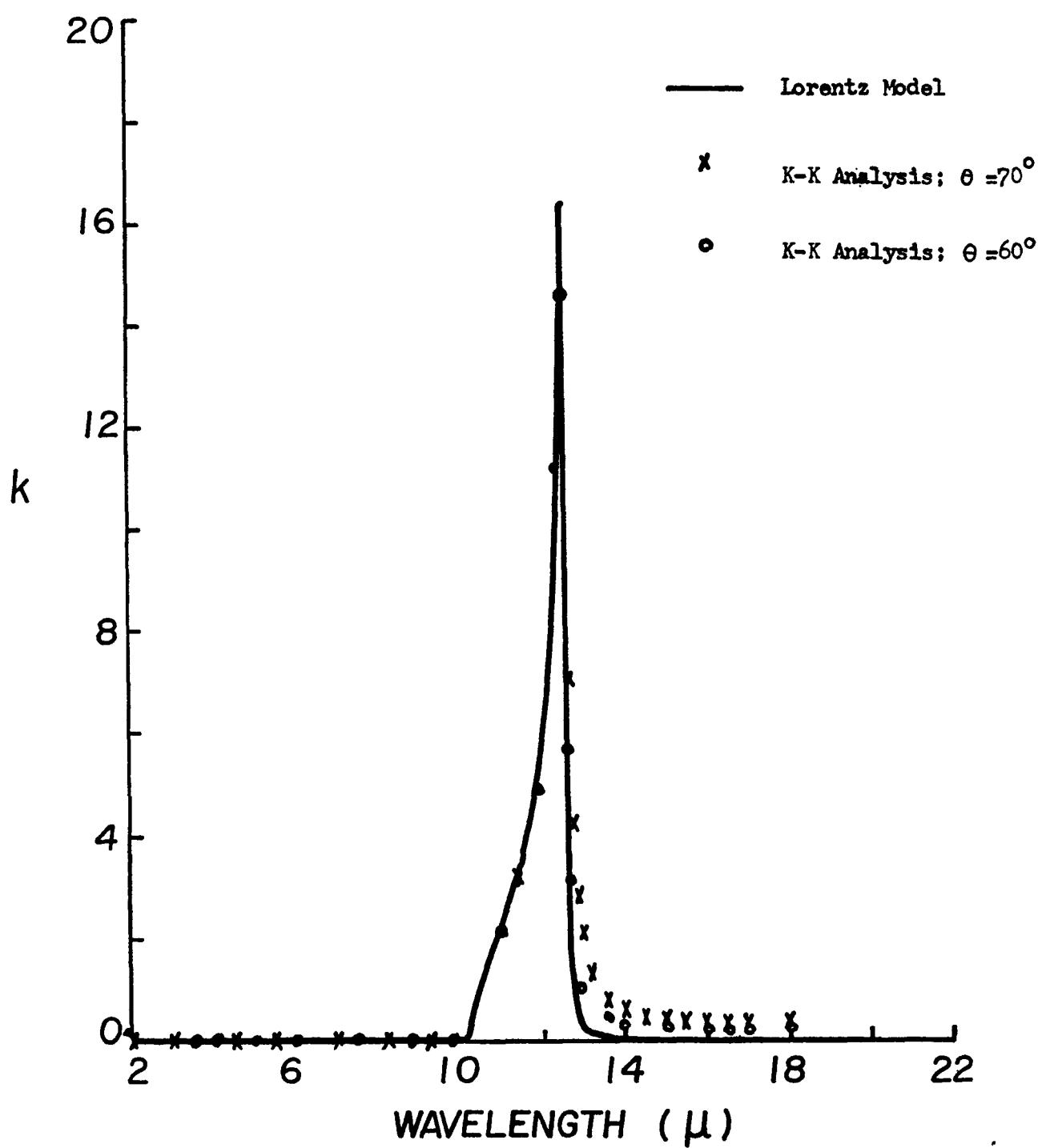


Fig. 4 Extinction Coefficient by Iterative K-K analysis compare with the values from Lorentz oscillator.

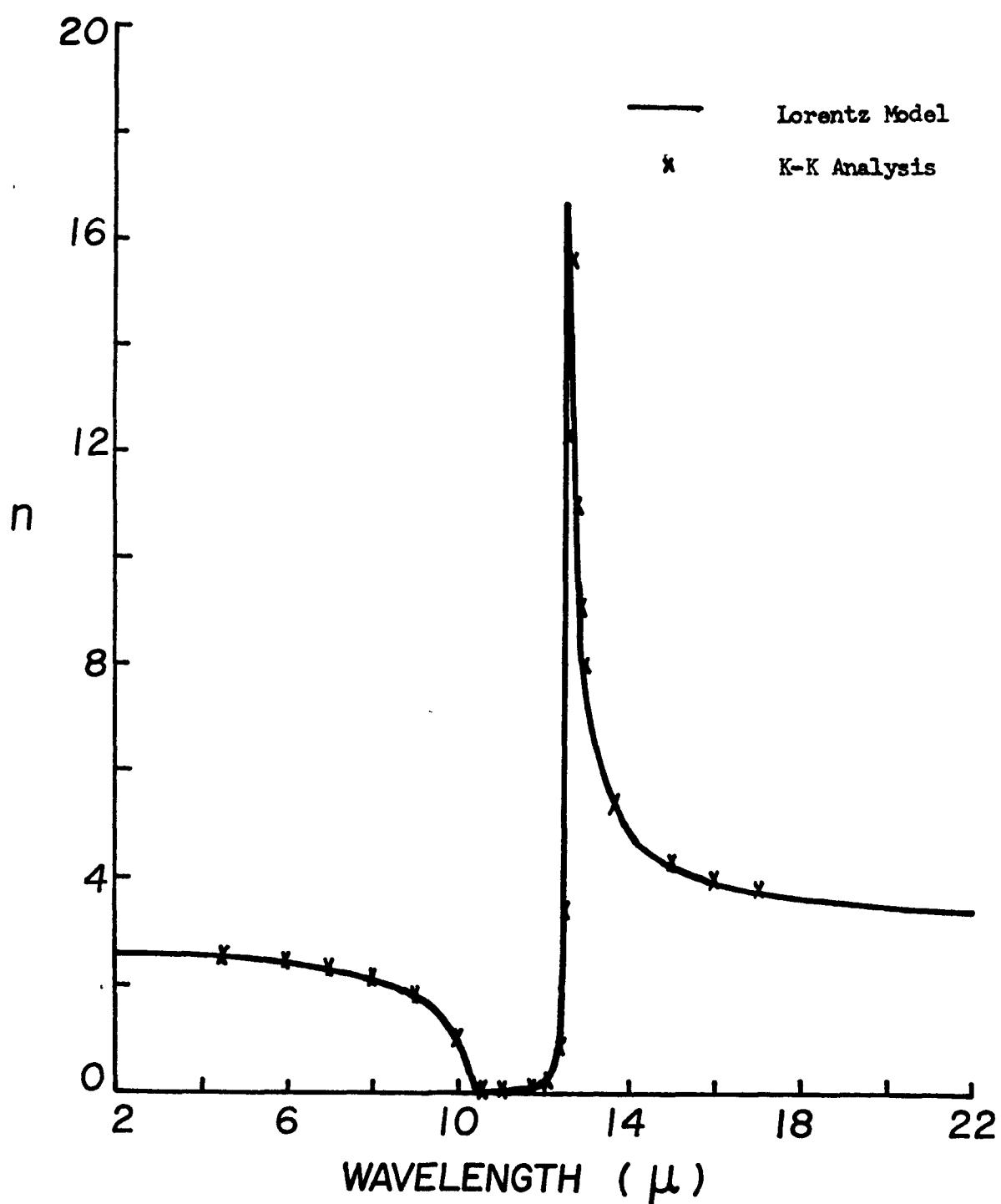


Fig. 5 Index of Refraction from the values of Extinction Coefficient
with K-K analysis.

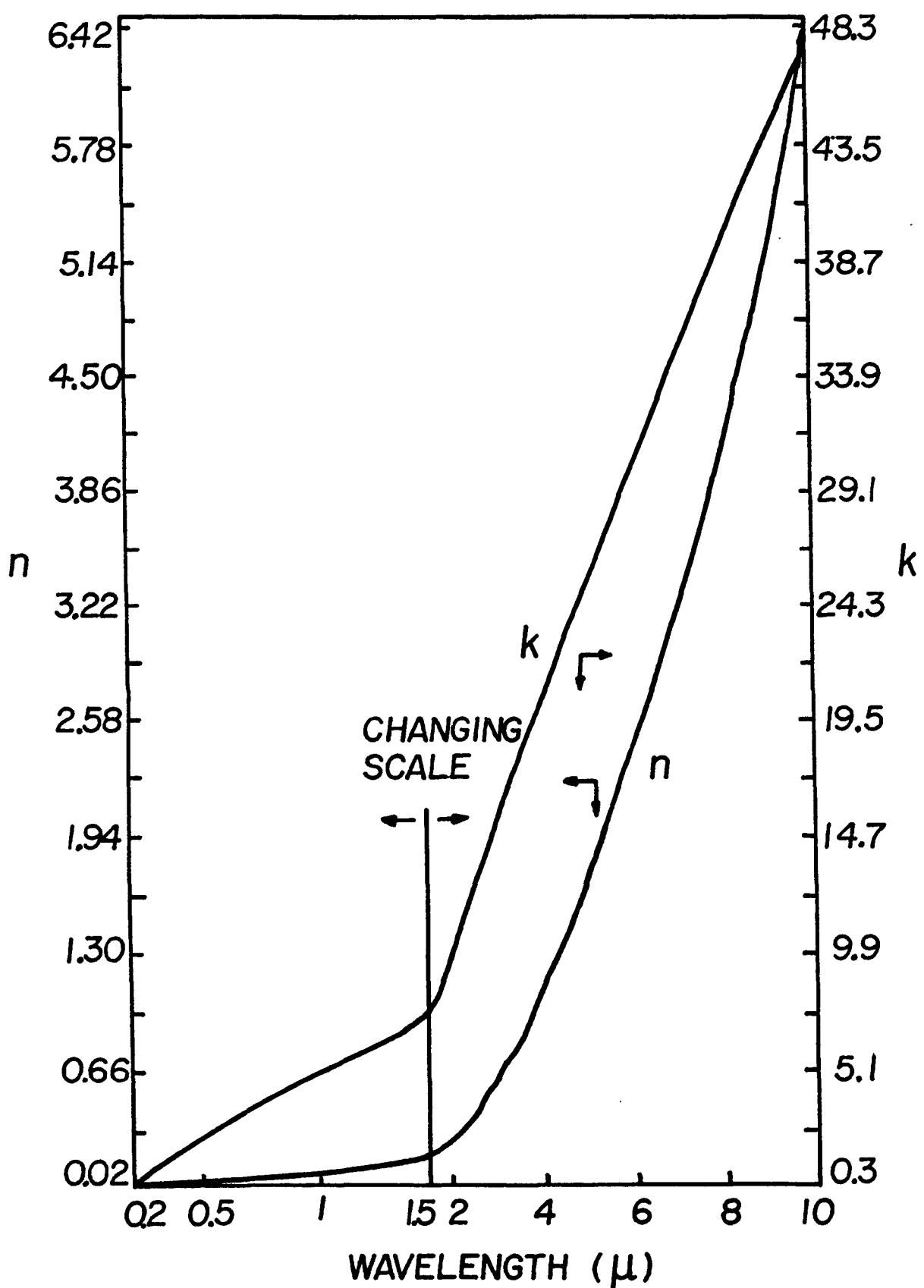


Fig. 6 Optical Constants of Sodium at Various Wavelength.
(From Ref. 5)

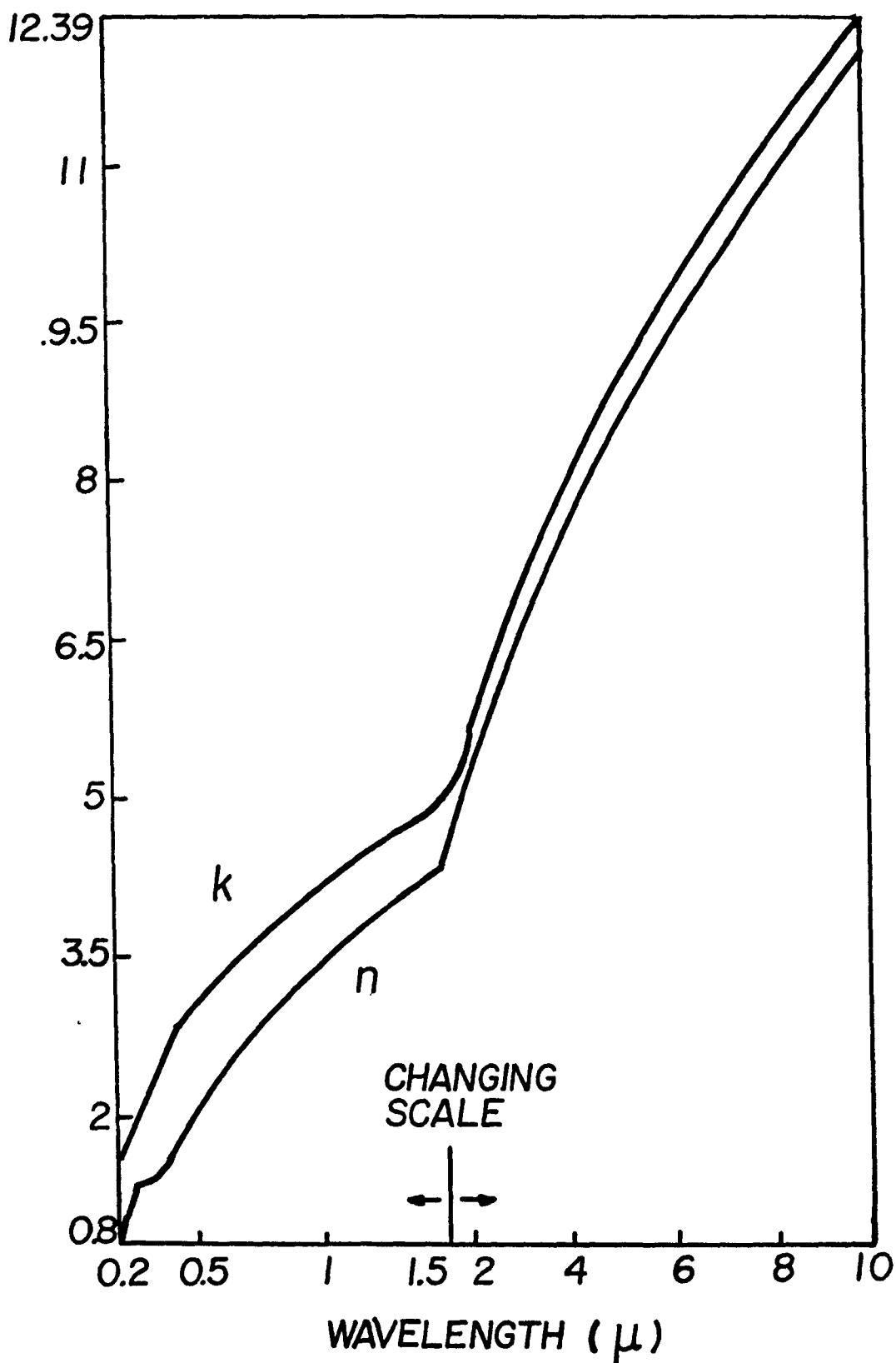


Fig. 7 Optical Constants of Steel at Various Wavelength
(From Ref. 5)

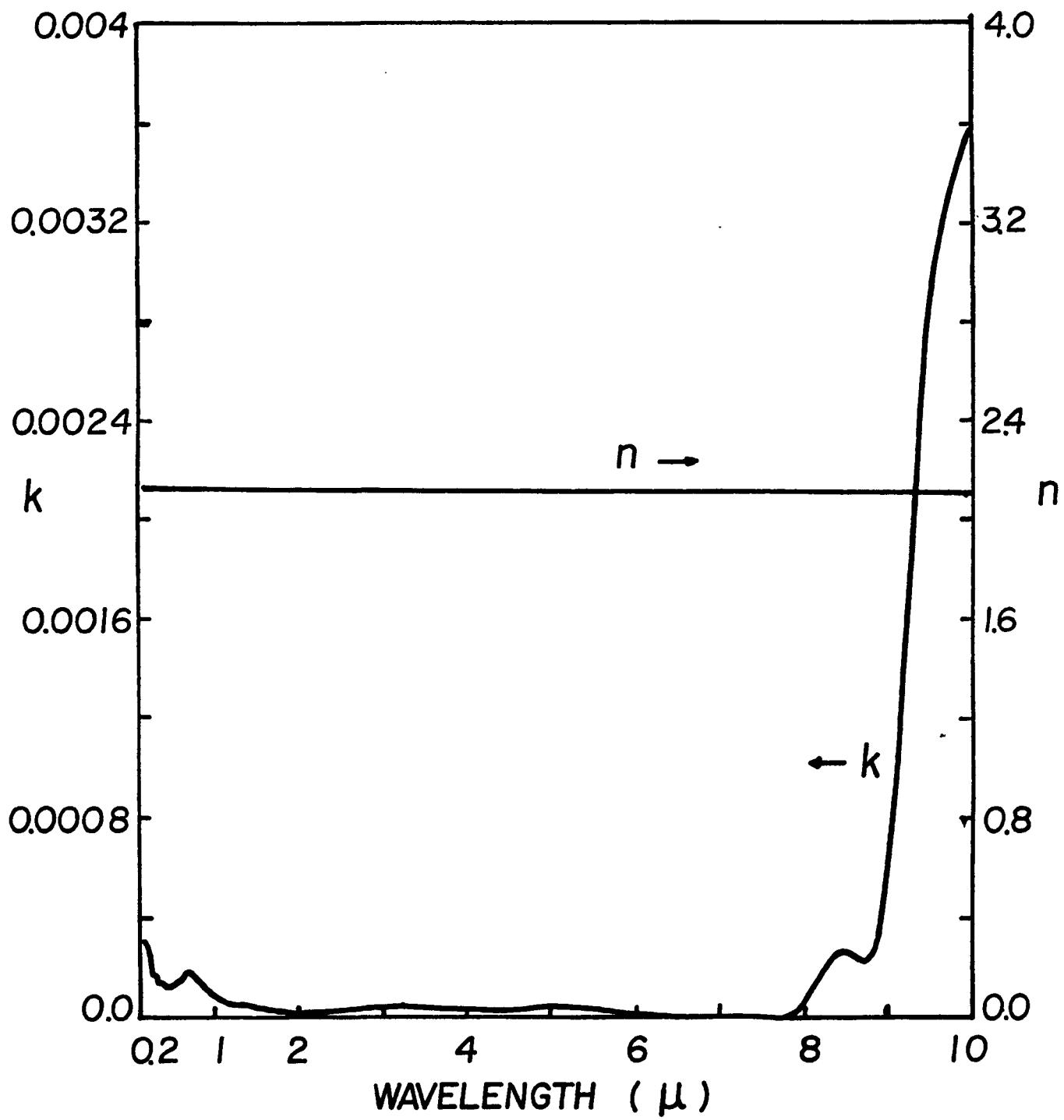


Fig. 8 Optical Constants of ThO_2 at Various Wavelengths

Based on the data of Table 4

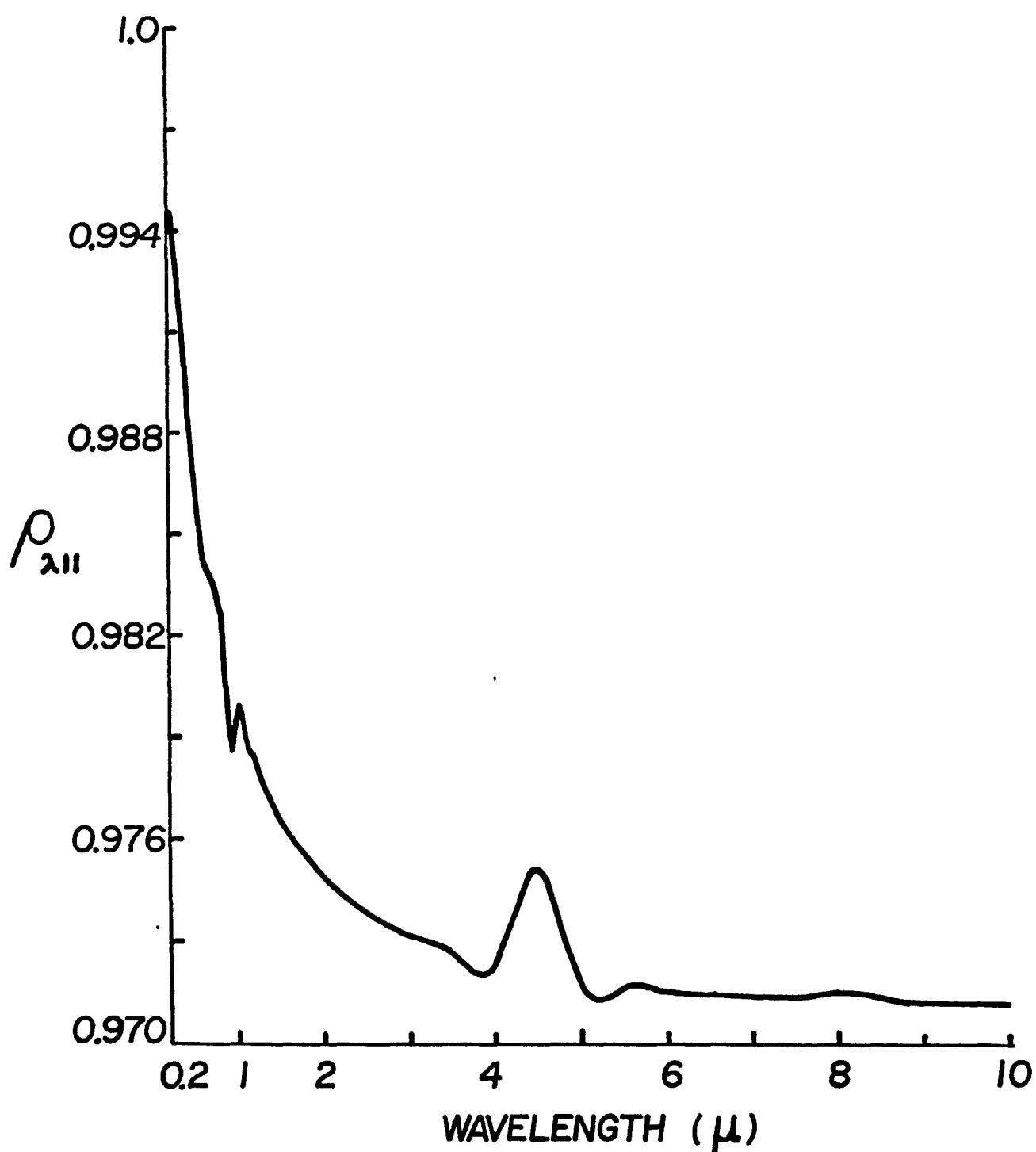


Fig. 9 ThO_2 -Sodium Interface Spectral Hemispherical Reflectance

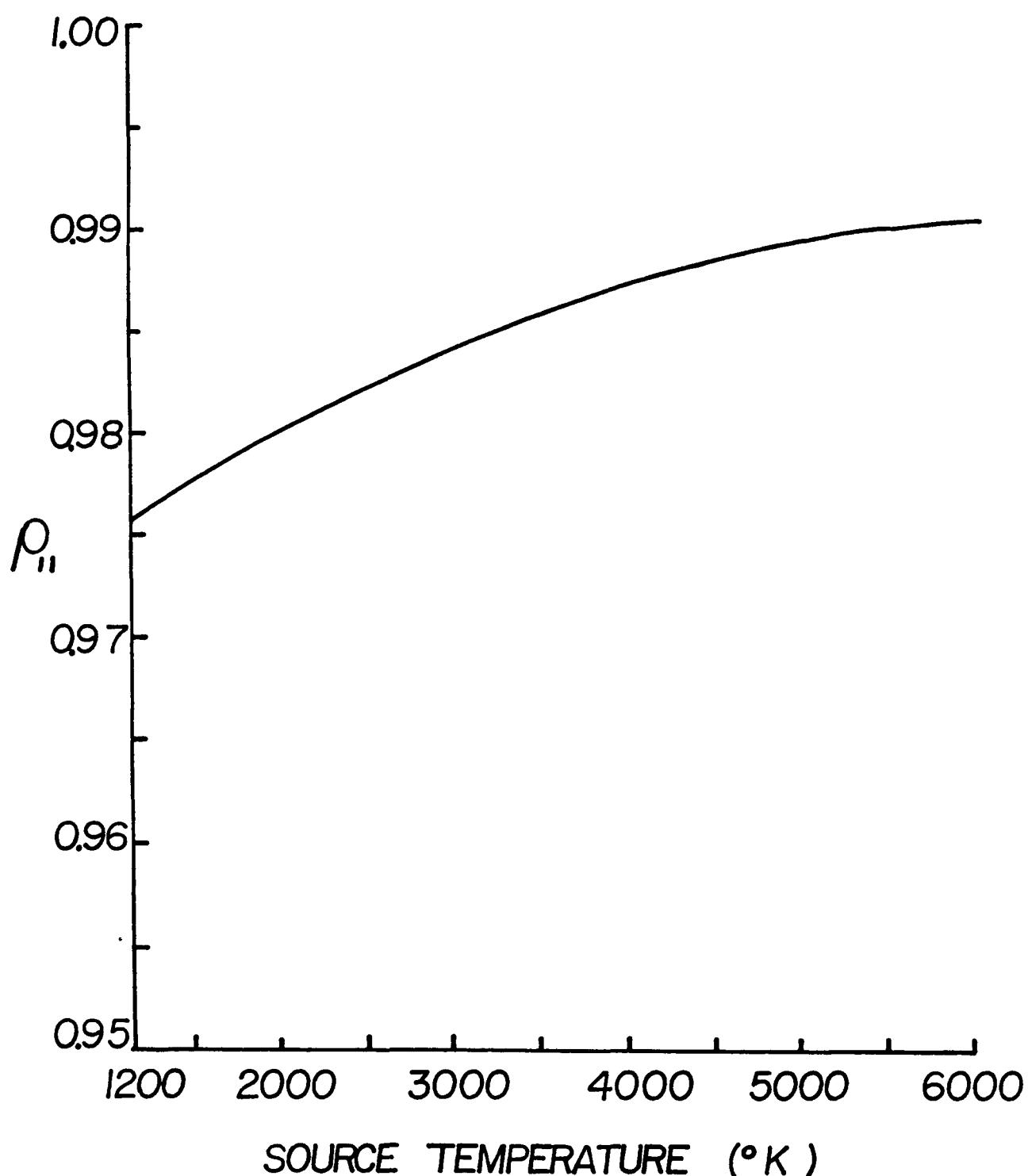


Fig. 10 ThO₂-Sodium Interface Total Hemispherical Reflectance

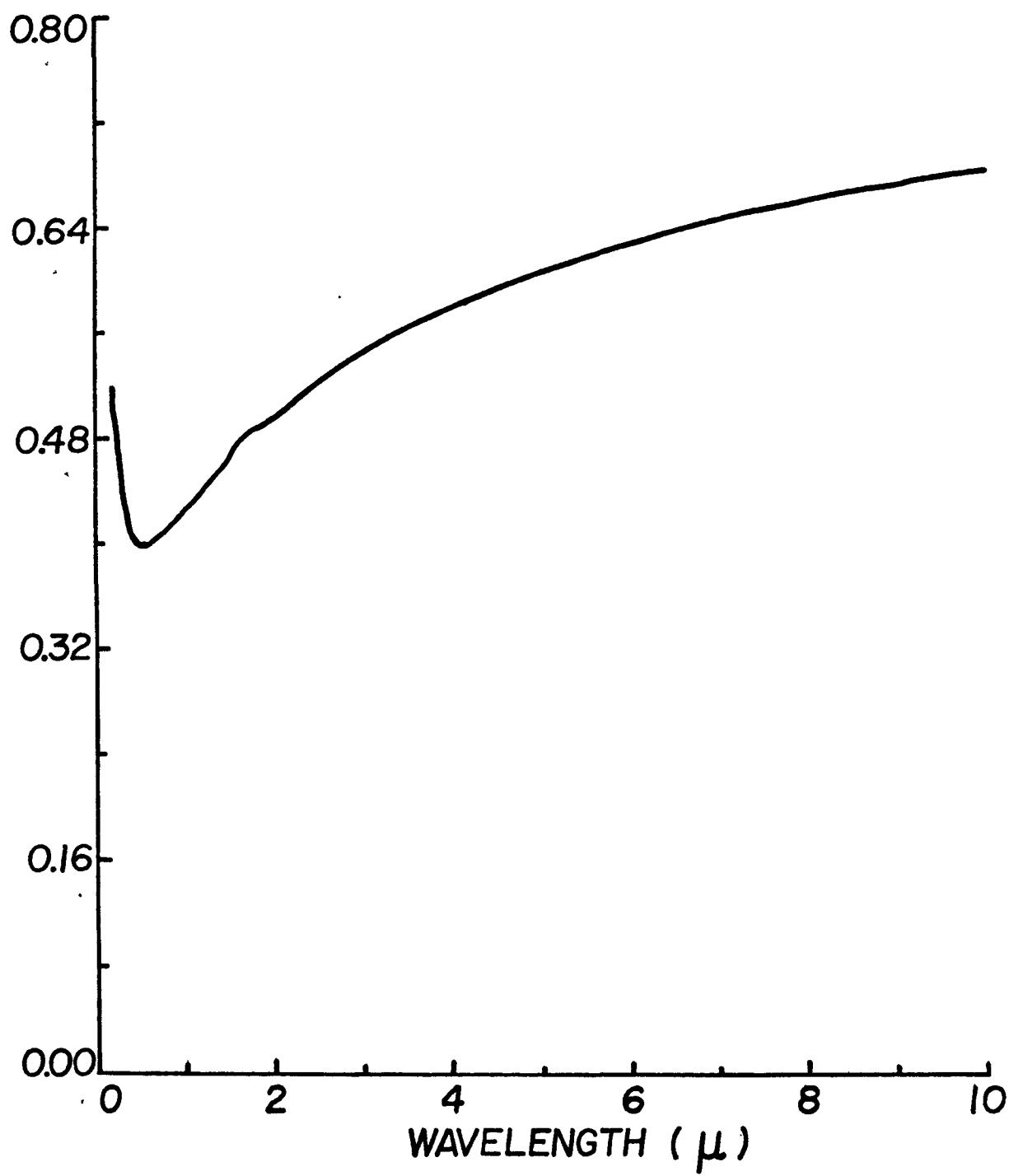


Fig. 11 ThO_2 -Steel Interface Spectral Hemispherical Reflectance

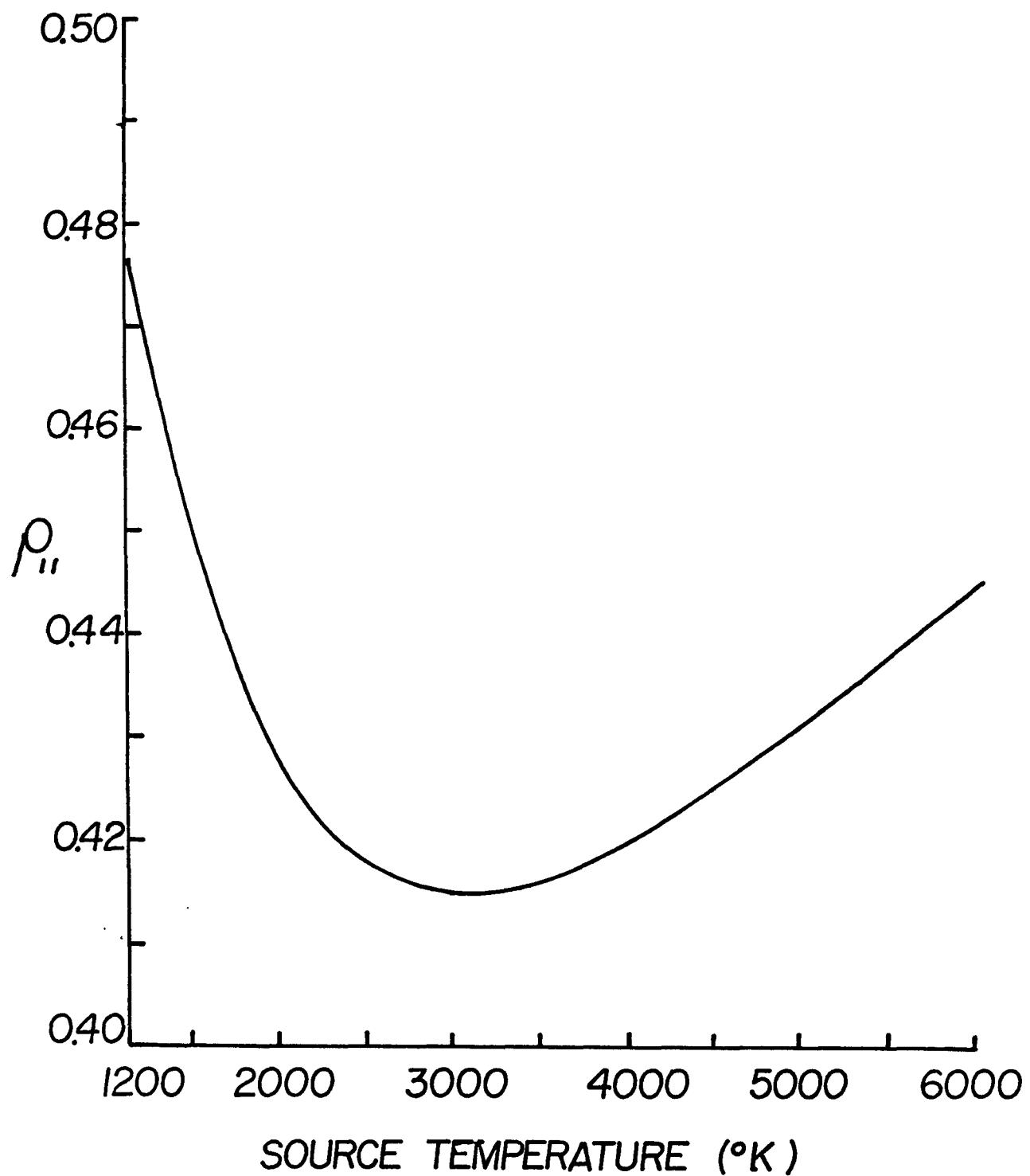


Fig. 12 ThO₂-Steel Interface Total Hemispherical Reflectance

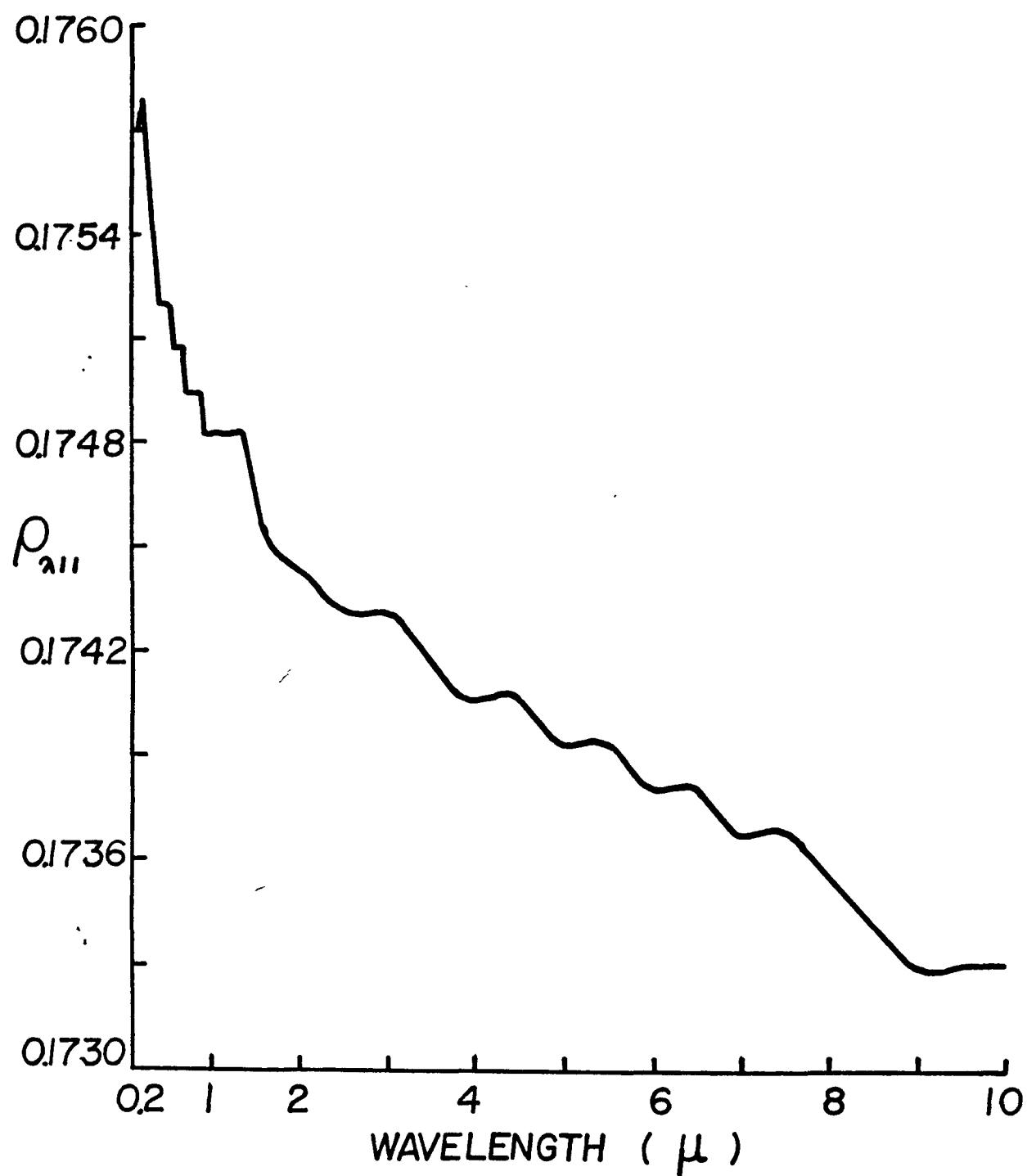


Fig. 13 Gas-ThO₂ Interface Spectral Hemispherical Reflectance

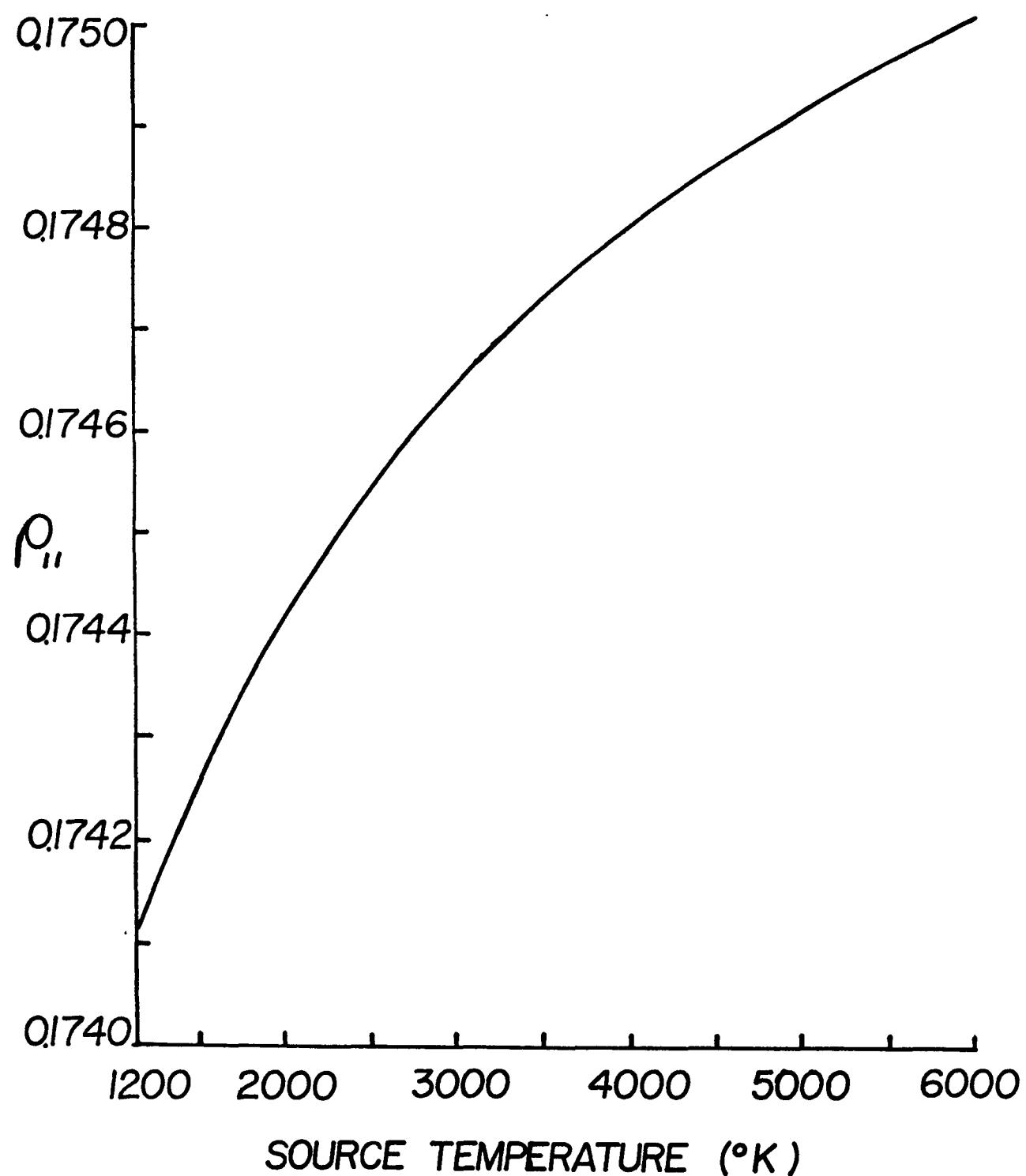


Fig. 14 Gas-ThO₂ Interface Total Hemispherical Reflectance

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APPENDIX A

LORENTZ OSCILLATOR (SEE REF. 13, pp. 42-45)

Consider an atom with electrons bound to the nucleus in much the same way as a small mass can be bound to a large mass by a spring.

The motion of an electron bound to the nucleus can be represented by,

$$m \frac{d^2 r}{dt^2} + m\gamma \frac{dr}{dt} + ma^2 r = -eE_{loc} \quad (A.1)$$

electronic acceleration force	viscous damping force	Hooke's restoring force	electric force
-------------------------------------	-----------------------------	-------------------------------	-------------------

where: m - electronic mass

e - magnitude of electronic charge

a - resonance frequency

γ - damping constant

r - displacement of electron

E_{loc} - local microscopic electric field acting on the electron

The local field can be taken to vary in time as $e^{i\omega t}$. Thus, the solution to Eq. (A.1) is

$$\hat{r} = \frac{-eE_{loc}/m}{(a^2 - \omega^2) - i\gamma\omega} \quad (A.2)$$

The induced dipole moment is

$$\hat{p} = \frac{e^2 E_{loc}/m}{(a^2 - \omega^2) - i\gamma\omega} \quad (A.3)$$

Note that it is important to be consistent in the form of the time variation in the electric field with the definition of the complex refractive index. The use of a time variation $e^{i\omega t}$ leads to a complex

refractive index $\hat{n} = n - ik$, and $e^{-i\omega t}$ leads to $\hat{n} = n + ik$.

Assume a linear relationship exists between \hat{p} and E_{loc} if the displacement r is sufficiently small,

$$\hat{p} = \hat{\alpha}(\omega) E_{loc} \quad (A.4)$$

where $\hat{\alpha}(\omega)$ is frequency-dependent atomic polarizability, and for a one-electron atom,

$$\hat{\alpha}(\omega) = (e^2/m) / [(a^2 - \omega^2) + i\gamma\omega] \quad (A.5)$$

For N one-electron atoms per unit volume, the macroscopic polarization is

$$P = N\hat{p} = N\hat{\alpha}(\omega) E_{loc} \quad (A.6)$$

Proceeding with the assumption the microscopic electric field E_{loc} can be approximated by the macroscopic field E , we have

$$P = N\hat{\alpha}(\omega)E = X_e E \quad (A.7)$$

X_e is macroscopic electric susceptibility.

Define a complex displacement \hat{D} such that

$$\hat{D} = \hat{\epsilon}E = \epsilon_0 E + 4\pi P \quad (A.8)$$

From Eqs. (A.7) and (A.8), the dielectric function $\hat{\epsilon}(-\epsilon_1 + i\epsilon_2)$ is

$$\hat{\epsilon} = \epsilon_0 + 4\pi N\hat{\alpha}(\omega) \quad (A.9)$$

Thus,

$$\hat{\epsilon} = \epsilon_0 + \frac{4\pi Ne^2}{m} \frac{1}{(a^2 - \omega^2) + i\gamma\omega} \quad (A.10)$$

From Maxwell's equations

$$\epsilon_1 = (n^2 - k^2)/\mu \quad (A.11)$$

$$\epsilon_2 = 2nk/\mu = 4\pi\sigma/\omega \quad (A.12)$$

μ : magnetic permeability. σ : conductivity. For non-magnetic materials, μ is equal to unity. We can find

$$\epsilon_1 = n^2 - k^2 = \epsilon_0 + \frac{4\pi Ne^2}{m} \frac{(a^2 - \omega^2)}{(a^2 - \omega^2) + \gamma^2 \omega^2} \quad (A.13)$$

$$\epsilon_2 = 2nk = - \frac{4 Ne^2}{m} \frac{\gamma \omega}{(a^2 - \omega^2)^2 + \gamma^2 \omega^2} \quad (A.14)$$

Again, from Eqs. (A.11) and (A.12), we find that for non-magnetic materials

$$n = \left\{ \frac{1}{2} \left[(\epsilon_1^2 + \epsilon_2^2)^{\frac{1}{2}} + \epsilon_1 \right] \right\}^{\frac{1}{2}} \quad (A.15)$$

$$k = \left\{ \frac{1}{2} \left[(\epsilon_1^2 + \epsilon_2^2)^{\frac{1}{2}} - \epsilon_1 \right] \right\}^{\frac{1}{2}} \quad (A.16)$$

Summary

Equations (A.13) and (A.14) can be cast into dimensionless form. Then the susceptibility X_e and conductivity in the neighborhood of a resonance frequency a are given by

$$X_e = \rho' \frac{1 - \nu'^2}{(1 - \nu'^2)^2 + \gamma'^2 \nu'^2} \quad (A.17)$$

and

$$(\sigma'/\nu') = - 2\pi \rho' \frac{\gamma' \nu'}{(1 - \nu'^2)^2 + \gamma'^2 \nu'^2} \quad (A.18)$$

where: ν' - is the measured frequency divided by a .

σ' - is the conductivity divided by a .

γ' - is called the width of the resonance.

ρ' - is given by $N e^2 / 4\pi^2 m a^2$ which is strength of the resonance.

And n , k can be written alternatively as

$$n^2 = \frac{1}{2} \left\{ (\varepsilon^2 + 4(\sigma/\nu)^2)^{\frac{1}{2}} + \varepsilon \right\} \quad (A.19)$$

$$k^2 = \frac{1}{2} \left\{ (\varepsilon^2 + 4(\sigma/\nu)^2)^{\frac{1}{2}} - \varepsilon \right\} \quad (A.20)$$

respectively, where

$$\varepsilon = \varepsilon_0 + 4\pi X_e \quad (A.21)$$

A.1 Criteria in Determining the Parameters of the Lorentz Model

In order to obtain a theoretical fit of Eqs. (A.17) and (A.18) to experimental data, the use of the following principles can be helpful:

a. The initial choice of α should correspond to the steepest point on the long wavelength side of the reflection peak. Alternatively one should use Havelock's²¹ formula

$$\alpha = \nu_{\max} \left(1 + \frac{n_+^2 - n_-^2}{6n_-^2 - 4} \right)^{\frac{1}{2}}$$

where: ν_{\max} is frequency at the reflectivity maximum, n_+ and n_- are the limiting indice of refraction at long and short wavelength, respectively.

b. The initial choice of ε_0 should give the observed limiting reflectivity at short wavelength according to the formula

$$R_{\nu \rightarrow \infty} = \left[\frac{\varepsilon_0^{\frac{1}{2}} - 1}{\varepsilon_0^{\frac{1}{2}} + 1} \right]^2$$

c. The initial choice of ρ should give the correct reflectivity on the long wavelength side of the band. It may be chosen to give the static electric constant according to the formulas (A.17) and (A.21) by taking the limit $\nu \rightarrow 0$.

d. The initial choice of γ is governed by the maximum reflectivity.

The approximation

$$\max R \sim 1 - (\delta/\pi\rho)$$

is rough but very useful.

Repeat with the process a to d , we can determine the values of these parameters by trial and error until the best fit is reached. Therefore, a theoretical spectrum of R_o can be calculated. In fact, with very limiting cases the theoretical curve can succeed in aligning with the experimental curve.

APPENDIX B

REFLECTANCE AND PHASE-SHIFT DISPERSION RELATION (REF. 13, pp. 244-248)

The derivation of the phase-shift dispersion relation requires that the complex reflectivity amplitude $\hat{r}(\omega)$ be analytically continued into the complex frequency plane. Suppose that $\hat{r}(\omega)$ and hence $\text{In}\hat{r}(\omega)$ can be analytically continued into the upper half of the complex frequency plane, which we denote as domain D. A contour integral as indicated in Fig. B.1 then yields the desired dispersion relation.

The linear causal relation between $E_r(\omega)$ and $E_i(\omega)$ require analyticity of $r(\omega)$ in the domain D as shown by the following:

$$E_r(t) = \int_{-\infty}^{\infty} E_r(\omega) e^{-i\omega t} d\omega \quad (\text{B.1})$$

$$E_r(\omega) = \hat{r}(\omega) E_i(\omega) \quad (\text{B.2})$$

$$E_i(\omega) = \frac{1}{2\pi} \int_{-\infty}^{\infty} E_i(t) \exp(i\omega t) dt' \quad (\text{B.3})$$

By substituting Eqs. (B.2) and (B.3) into Eq. (B.1), it yields

$$E_r(t) = \int_{-\infty}^{\infty} G(t-t') E_i(t') dt' \quad (\text{B.4})$$

where:

$$G(t-t') = \frac{1}{2\pi} \int_{-\infty}^{\infty} \hat{r}(\omega) \exp[-i\omega(t-t')] d\omega \quad (\text{B.5})$$

which is the Fourier transform of $\hat{r}(\omega)$. If this transform can be inverted, then,

$$\hat{r}(\omega) = \int_{-\infty}^{\infty} G(T) e^{i\omega T} dT ; \quad T \equiv t-t' \quad (\text{B.6})$$

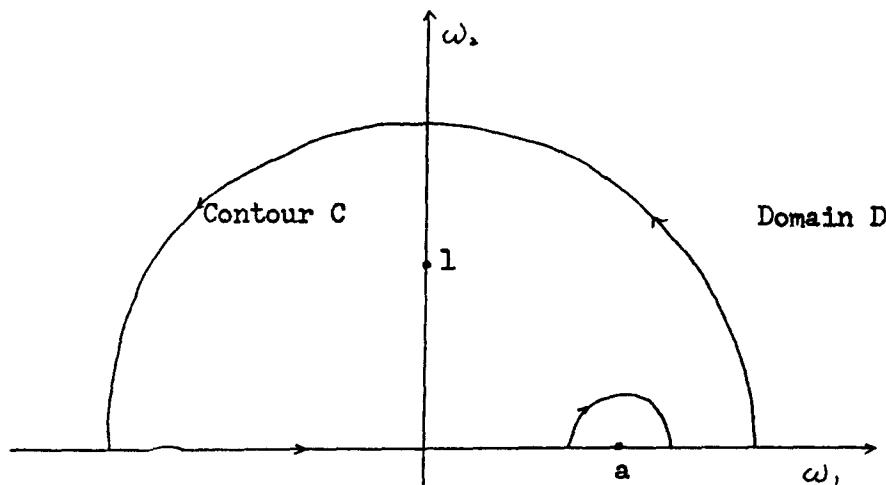


Fig. B.1 Integration Contour in Complex Frequency Plane
 $\hat{\omega} = \omega_1 + i\omega_2$

We want to derive a dispersion relation for $\text{In}\hat{r}(\hat{\omega})$, i.e., we want an integral relationship between $\text{In}\hat{r}(\hat{\omega})$ and $\theta(\hat{\omega})$ so we can eliminate one of the unknowns in the equation

$$\text{In}\hat{r}(\hat{\omega}) = \text{In}\hat{r}(\hat{\omega}) + i\theta(\hat{\omega}) \quad (\text{B.7})$$

Therefore, a function other than $\text{In}\hat{r}(\hat{\omega})$ must be used for the integration over the contour shown in Fig. B.1. The function

$$f(\hat{\omega}) = (1+a\hat{\omega}) \text{In}\hat{r}(\hat{\omega}) / [(1+\hat{\omega}^2)(a-\hat{\omega})] \quad (\text{B.8})$$

which can be integrated over the contour C satisfies the dispersion relation for $\text{In}\hat{r}(\hat{\omega})$.

Integrating Eq. (B.8), we have

$$\int_C \frac{(1+a\hat{\omega}) \text{In}\hat{r}(\hat{\omega})}{(1+\hat{\omega}^2)(a-\hat{\omega})} d\hat{\omega} = 2\pi i \sum_j \text{Res}(\hat{\omega}_j) \quad (\text{B.9})$$

This becomes

$$\text{p.v. } \int_{-\infty}^{\infty} \frac{(1+a\omega) \text{In}\hat{r}(\hat{\omega})}{(1+\omega^2)(a-\omega)} d\omega + i\pi \text{In}\hat{r}(a) = i\pi \text{In}\hat{r}(i) \quad (\text{B.10})$$

since the only pole enclosed by the contour is $\hat{\omega}=i$, and the only pole on the contour is $\hat{\omega}=a$. From Eq. (B.6), we see $\hat{r}(i)$ is real, so is $\text{In}[\hat{r}(i)]$. Substituting Eq. (B.7) into (B.10) and equating the real parts of the resulting equation, we find

$$\phi(a) = \frac{1}{\pi} \text{p.v.} \int_{-\infty}^{\infty} \frac{1+a\omega}{1+\omega^2} \text{In}[\rho(\omega)] \frac{d\omega}{a-\omega} \quad (\text{B.11})$$

Using Eq. (B.2), we see that the complex conjugate of r is

$$\hat{r}^*(\omega) = E_x^*(\omega)/E_1^*(\omega) = E_x(-\omega)/E_1(-\omega) \quad (\text{B.12})$$

$$\text{so } \hat{r}^*(\omega) = \hat{r}(-\omega) \quad (\text{B.13})$$

$$\text{and } \text{In}[\rho(\omega)] = \text{In}[\rho(-\omega)] \quad (\text{B.14})$$

Considering integration of Eq. (B.11) over negative frequencies and using Eq. (B.14), we have

$$\frac{1}{\pi} \text{p.v.} \int_{-\infty}^0 \frac{(1+a\omega) \text{In}\rho(\omega)}{(1+\omega^2)(a-\omega)} d\omega = \frac{1}{\pi} \text{p.v.} \int_0^{\infty} \frac{(1-a\omega) \text{In}\rho(\omega)}{(1+\omega^2)(a+\omega)} d\omega \quad (\text{B.15})$$

Therefore, Eq. (B.11) becomes

$$\phi(a) = \frac{2a}{\pi} \text{p.v.} \int_0^{\infty} \frac{\text{In}\rho(\omega)}{a^2 - \omega^2} d\omega \quad (\text{B.16})$$

The singularity at $\omega=a$ is removed by subtracting

$$\frac{2a}{\pi} \text{p.v.} \int_0^{\infty} \frac{\text{In}\rho(a)}{a^2 - \omega^2} d\omega = 0 \quad (\text{B.17})$$

from Eq. (B.16). Then from the normal reflectivity relation

$$R(\omega) = \hat{r}(\omega)\hat{r}^*(\omega) = \rho^2 \quad (\text{B.18})$$

we obtain the desired dispersion relation

$$\phi(a) = \frac{a}{\pi} \int_0^{\infty} \frac{\text{In}[R(\omega)/R(a)]}{a^2 - \omega^2} d\omega \quad (\text{B.19})$$

There are several notable features of Eq. (B.19). A fractional error in reflectance, that is, a measurement which yields the same percentage error in reflectance at all frequencies, does not affect the phase. Such errors still yield the correct reflectance ratio $R(\omega)/R(a)$, and no effect to the phase at $\omega=a$.

APPENDIX C

NUMERICAL INTEGRATION OF THE PHASE-SHIFT EQUATION

The phase-shift equation,

$$\phi(a) = -\frac{2a}{\pi} \int_0^\infty \frac{\ln R_s^{\frac{1}{2}}(\omega)}{\omega^2 - a^2} d\omega \quad (C.1)$$

can be written, after integrating by parts, as

$$\phi(a) = \frac{1}{\pi} \int_0^\infty \ln \left| \frac{\omega-a}{\omega+a} \right| \frac{d \ln R_s^{\frac{1}{2}}(\omega)}{d\omega} d\omega \quad (C.2)$$

To integrate by part one more time, let us choose

$$u = d \ln R_s^{\frac{1}{2}}(\omega) / d\omega ; \quad dv = \left[\ln|\omega-a| - \ln(\omega+a) \right] d\omega$$

Then,

$$\begin{aligned} \phi(a) &= \frac{1}{\pi} \left\{ \frac{d \ln R_s^{\frac{1}{2}}(\omega)}{d\omega} \left[(\omega-a) \ln|\omega-a| - (\omega+a) \ln(\omega+a) + 2a \right] \right\}_0^\infty \\ &\quad - \int_0^\infty \left[(\omega-a) \ln|\omega-a| - (\omega+a) \ln(\omega+a) + 2a \right] \frac{d^2 \ln R_s^{\frac{1}{2}}(\omega)}{d\omega^2} d\omega \quad (C.3) \end{aligned}$$

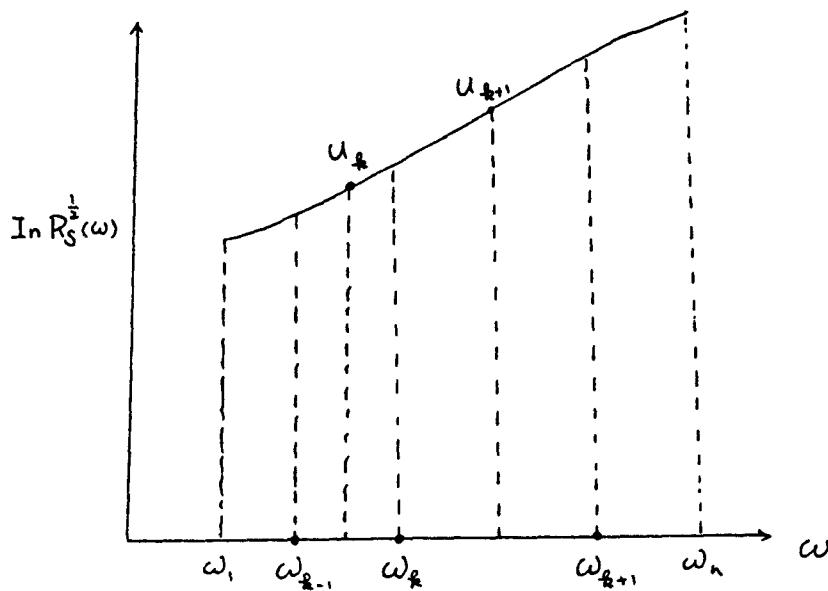
Because it is complex integral, we should use Cauchy principle value to simplify the integral to the desired form. Assume the slope of $R_s(\omega)$ is zero at $\omega=0$, and $\omega \rightarrow \infty$, the first term on the right hand side of Eq. (C.3) is then zero. Also for the last term in the integral,

$$\frac{2a}{\pi} \int_0^\infty \frac{d^2 \ln R_s^{\frac{1}{2}}(\omega)}{d\omega^2} d\omega = 0 \quad (C.4)$$

Thus, it is only left with

$$\phi(a) = \frac{1}{\pi} \int_0^\infty \left[(\omega+a) \ln(\omega+a) + (a-\omega) \ln|\omega-a| \right] \frac{d^2 \ln R_s^{\frac{1}{2}}(\omega)}{d\omega^2} d\omega \quad (C.5)$$

In reference to the sketch, let



$$u_k = \frac{\ln R_s^{\frac{1}{2}}(\omega_k) - \ln R_s^{\frac{1}{2}}(\omega_{k-1})}{\omega_k - \omega_{k-1}} \quad \text{at } \frac{\omega_k + \omega_{k-1}}{2}$$

$$u_{k+1} = \frac{\ln R_s^{\frac{1}{2}}(\omega_{k+1}) - \ln R_s^{\frac{1}{2}}(\omega_k)}{\omega_{k+1} - \omega_k} \quad \text{at } \frac{\omega_k + \omega_{k+1}}{2}$$

$$\frac{d^2 \ln R_s^{\frac{1}{2}}(\omega)}{d\omega^2} d\omega = u_{k+1} - u_k = \gamma_k$$

Therefore,

$$\phi(a) = \frac{1}{\pi} \sum_{k=2}^{n-1} \gamma_k ((\omega+a) \ln(\omega+a) + (a-\omega) \ln|a-\omega|) \quad (C.6)$$

In using this formula it is essential to impose the first two values ($k=1, 2$) of $R_s(\omega)$ be the same. So are the last two values ($k=n-1, n$) because of the assumption imposed.

APPENDIX D

Optical Density of Single Crystal ThO₂
From Bates' Report (Ref. 16)

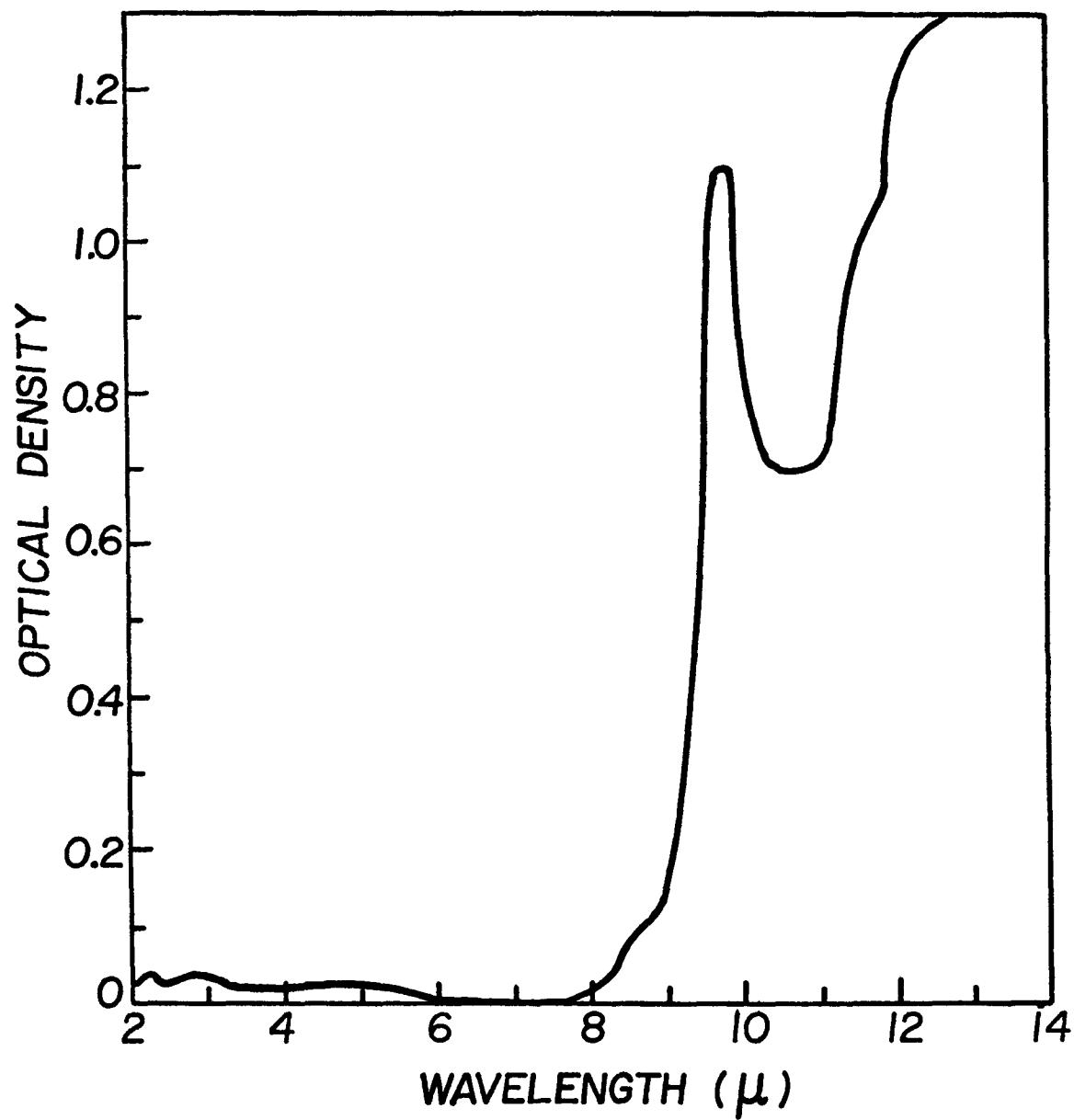


Fig. D.1 Infrared Absorption Spectrum of Single Crystal ThO_2
(Sample Thickness is 0.048 cm)

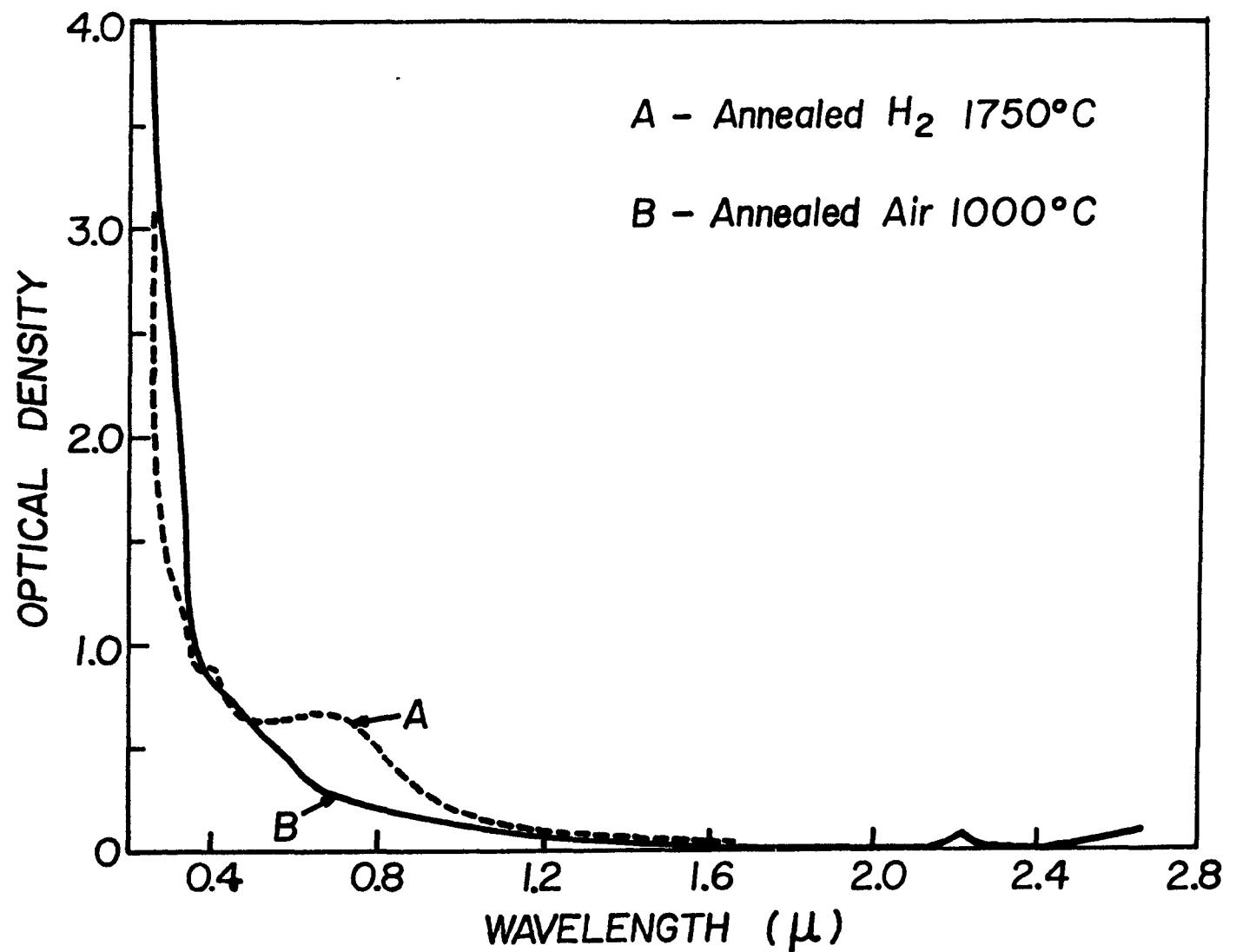


Fig. D.2 Ultraviolet, Visible, and Infrared Absorption Spectra of Single Crystal ThO_2

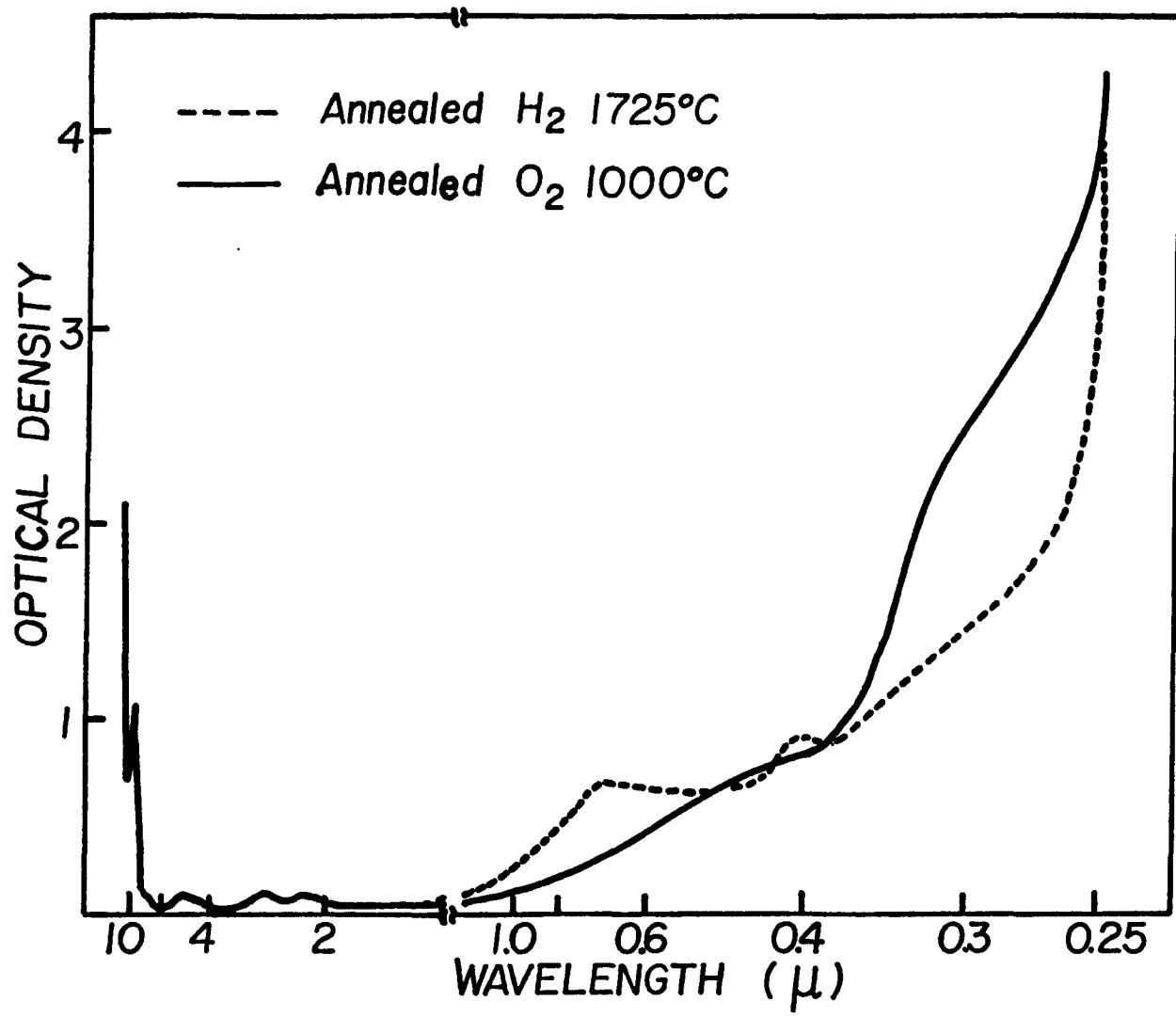


Fig. D.3 Ultraviolet, Visible, and Infrared Absorption Spectra of
Single Crystal ThO_2

APPENDIX E

FORTRAN Program for the K-K Iterative Method

FORTRAN Implementation

Lorentz Oscillator:

Program Symbol	Definition
N	Number of segment
POL	Polarization
WI	Wavelength at short side (μ)
VO	Resonance wavelength (μ)
BO	Dielectric Constant at long wavelength
T	Strength of resonance
GARMA	Damping constant
THETA	Incidence angle (radian)
EPS	A positive number less than 10^{-5}
R	Reflectivity at normal incident angle
RO	Experimental reflectivity
ZN	Index of refraction
ZK	Extinction coefficient

Iterative K-K Analysis:

Program Symbol	Definition
M	Number of iteration
N	Number of Points
PHI	Incidence angle (radian)
POL	Polarization
RO(K)	Values of experimental reflectivity
THETA	Phase angle
X(K)	Wavelength (μ)

Index of Refraction from K-K Theory:

Program Symbol	Definition
E1	Dielectric constant at short wavelength (ϵ)
N	Number of Values
Y(K)	Values of wavelengths (λ)
ZN(K)	Values of index of refraction
ZK(K)	Values of extinction coefficient

APPENDIX F

FORTRAN Program for the Calculation of Surface Radiation
Properties of ThO₂ and the Related Reactor Materials

FORTRAN Implementation

Spectral Hemispherical Properties:

Program Symbol	Definition
WA	Resonance wavelength
Y1	Index of refraction at medium 1
Y2	Index of refraction at medium 2
Z1	Extinction coefficient at medium 1
Z2	Extinction coefficient at medium 2

Total Hemispherical Properties:

Program Symbol	Definition
EO(I)	Values of spectral hemispherical emittance
TE	Source temperature
Y1(J)	Values of wavelength (μ)
VALUE	Total hemispherical emittance
VAL	Total hemispherical reflectance

FOR, ASIZ
FOR PETZ-38/10/72-11:12:03

MAIN PROGRAM

STORAGE ALLOCATION OUTPUT DATAFILE, SUB-LIST BLANK COMMON TO SELECT

EXTERNAL REFERENCES (BLOCK#, NAME)

FC007 MINT.PS
FC004 C01
FC005 C01A
FC006 T01
FC007 S14.R
FC010 X01.RR
FC011 N01.DD
FC012 N01.DD
FC013 N01.DD.PS

STORAGE ASSIGNMENT (BLOCK#, TYPE, RELATIVE LOCATION#, NAME)

FC000	BLK004 100	FC001	BLK004 110	FC002	BLK004 200	FC003	BLK005 100	FC004	BLK013 400
FC001	BLK014 500	FC002	R BLK002 AA	FC003	R BLK005 AAA	FC004	R BLK022 E	FC005	R BLK034 PS
FC000	R BLK000 50	FC003	R BLK003 PS	FC004	R BLK001 EPS	FC005	R BLK011 CAPMA	FC006	I BLK017 I
FC000	I BLK000 N	FC004	I BLK012 NEA	FC005	R BLK007 R	FC006	R BLK007 SI	FC007	R BLK002 PCL
FC000	R BLK005 2	FC005	R BLK005 CSQ	FC006	R BLK033 R	FC007	R BLK043 RO	FC008	R BLK042 R?
FC000	R BLK041 PS	FC006	R BLK021 SIV	FC007	R BLK024 SIVS	FC008	R BLK016 T	FC009	R BLK004 THETA
FC000	R BLK017 V	FC007	R BLK016 VA	FC008	R BLK017 V0	FC009	R BLK005 VC	FC010	R BLK014 W
FC000	R BLK003 WI	FC008	R BLK020 Y	FC009	R BLK040 Z	FC010	R BLK032 ZK	FC011	R BLK071 ZKK
FC000	R BLK030 PW	FC009	R BLK027 ZNN						

00101	10	V=000	00000
00107	10	EPS=0.00000001	000003
00104	10	POL004	000005
00105	10	WT=0.	000006
00106	10	THTA=1.0472	000010
00107	10	VO=10.0	000012
00108	10	BO=0.7	000014
00111	10	PT=3.141592	000016
00112	10	TEC=0.67	000018
00117	10	CAPMAPP=0.0F	000022
00114	10	VOLEN=1	000024
00115	10	DO=1. T#1+NP1	000025
00100	10	WE=WT+0.1*FLCAT(T-1)	000026
00121	14	V=V0/W	000027
00102	15	VA=1.-V**2	000027
00123	15	VB=CAPMA*V	000102
00124	15	YET=VA/VVA**2+VN**2	000105
00125	15	-ST=V0.*PT*T+*P/(VA**1+VB**1)	000114
00126	15	DE=V0+VA.*PT*X	000120
00127	20	DO=V0.*T	000127
00128	21	ST=V0/STV**2	000128

00171	23*	AA=7.5+4.*STY.	000177
00172	27*	AA=500T(1-WA)	000178
00173	26*	ZMEL=7*(AA+.)	000176
00174	27*	ZMEN=5*(MM)	000141
00175	28*	IF(7MM.LT.7E-10) TO 10	000143
00176	27*	ZM=5.*ZT(7MM)	000148
00177	27*	GO TO 10	000157
00178	28*	10 7M=0.	000154
00179	29*	10 7K=0.	000155
00180	30*	10 7K=500T(1-KK)	000160
00181	31*	7K=7.5*(KK)	000167
00182	32*	IF(7K>L.T.7E-10) TO 41	000168
00183	33*	7K=500T(1KK)	000171
00184	34*	GO TO 10	000177
00185	35*	10 7K=0.	000174
00186	36*	10 RE=((Z**L+ZK**2)/(L**2+ZK**2))	000212
00187	37*	39=7M**2-ZK**2-(SIN(7HTTA))**2	000221
00188	38*	2.0=-(2.4*(Z**2+4.*((2N+7K)*L))**2/12.	000235
00189	39*	0=3.0*T(0.0)	000250
00190	40*	RE=(7M+7K)/G	000255
00191	41*	ZE=((9-COS(7HTTA))**2+P**2)/(1.0+COS(7HTTA))**2+P**2)	000264
00192	42*	RFSE=((P-SIN(7HTTA)+TAN(7HTTA))**2+P**2)/(1.0+SIN(7HTTA)+TAN(7HTTA))	000274
00193	43*	*)**2+P**2)	000277
00194	44*	RPERD=3.7	000277
00195	45*	RO=7.5*(1.+7CL)+7E+(1.+7CL))	000302
00196	46*	WRTE(7.10)W=LN,ZK,R=Z,RO	000317
00197	47*	10 FORMAT(1H0.5X,*WF=7,F10.5,FX,7ME-7,F10.5,FX,*ZKE=7,F10.5,FX,	000317
00198	48*	6'R=7,F10.5+5X,*Z=7,7CL,5+5X,*RDE=7,F10.5)	000317
00199	49*	10 CONTINUE	000317
00200	50*	10 STOP	000323
00201	51*	END	

END OF COMPIRATION: NO DIAGNOSTICS.

FOR, ASIZ
FOR JF37=1/15/79-19:25:05

MAIN PROGRAM

STORAGE USED: CCDE(1) 000600; DATA(U) 002773; BLANK COMMON(L) ~00000

EXTERNAL REFERENCES (BLOCK, NAME)

J003 NINTRY
J004 NRCS
J005 COS
J006 SIN
J007 TAN
J010 NIC2S
CC11 V101S
CC12 NWDTU
S017 ALOC
S014 SGPT
C015 XPPR
J014 NSTC7

STORAGE ASSIGNMENT (BLOCK, TYPE, RELATIVE LOCATION, NAME)

J007	002621	1CF	(001	000360	114C	0001	007665	120G	0001	000077	127C	0001	000104	133G
J001	001112	141G	(001	000120	147G	0001	000125	155G	0001	000133	160G	0001	000174	171G
J001	000200	175G	(001	000247	2L	0000	002624	20F	0001	000526	25L	0001	000446	253G
J001	000470	26L	(001	000564	27L	0001	000504	276G	0001	000425	30L	0001	000542	321G
J001	000572	37L	(001	000254	4L	0000	002624	40F	0001	000455	42L	0001	000466	44L
J001	0002670	57F	(001	000513	52L	0001	000524	54L	0001	000551	57L	0001	000562	59L
J001	000441	77L	(001	000477	71L	0001	000575	74L	0000	R 000000	A	0000	R 002607	AMW
J000	R 002616	AFN	(000	R 000144	B	0000	R 000311	C	0000	R 000454	D	0000	I 002603	I
J000	I 002620	II	(000	I 002577	ITER	0000	I 002675	J	0000	I 002575	JJ	0000	I 002574	K
J000	I 002576	KK	(000	I 002606	L	0000	I 002671	L#1	0000	I 002570	M	0000	I 002571	N
J000	I 002672	NN1	(000	R 000620	P	0000	F 002571	PHI	0000	R 002606	PI	0000	R 002614	PN
J000	R 002573	POL	(000	R 002617	PQ	0000	R 002617	W	0000	R 001604	R	0000	R 002612	RD
J000	R 002614	FREW	(000	R 002260	RO	0000	F 002615	RFS	0000	R 002616	RS	0000	R 002611	THESUB
J000	R 001110	THETA	(000	R 002604	THETAA	0000	F 002764	U	0000	R 001750	W	0000	R 002424	X
J000	R 001440	ZY	(000	R 001274	ZN									

00101	1*	DIMENSION A(100),P(100),C(100),D(100),P(100),U(100),THETA(100), 12K(100),ZK(100),R(100),W(100),RNEL(100),R0(100),X(100)	0000000
00101	2*	12K(100),ZK(100),R(100),W(100),RNEL(100),R0(100),X(100)	0000000
00103	3*	READ(5,1u)M,N,PHI,POL	0000001
C0111	4*	10 FORMAT(13,13,F10.4,F6.5)	000040
L0112	5*	READ(5,2u)(X(K),K=1,N),(RC(K),K=1,L)	0000740
C0124	6*	20 FORMAT(EF10.4)	0000070
L0125	7*	WRITE(6,40)(X(K),K=1,N),(FO(K),K=1,M)	000070
C0137	8*	40 FORMAT(2x,5F10.4)	000112
L0140	9*	DO 111 JJ=1,N	000112
L0143	10*	W(JJ)=1000.0/X(JJ)	000112
00144	11*	111 CONTINUE	000120
C0145	12*	DO Z1 K=1,N	000120

L0151	13*	R(KK)=RC(KK)	000120
L0152	14*	31 CONTINUE	000125
L0154	15*	DO 33 ITLR=1,M	000125
L0157	16*	DO 80 L=L,N	000133
L0162	17*	L*1=L-1	000133
L0163	18*	A(L)=(1./Z*)*(ALUG(R(L))-ALOG(R(LM1)))	000137
L0164	19*	E(L)=W(L)-W(LM1)	000155
L0165	20*	SJ U(L)=A(L)/B(L)	000160
L0167	21*	NM1=L-1	000164
L0172	22*	DO 70 I=L,NM1	000166
L0173	23*	THE TAA=0.	000174
L0174	24*	DO 4 J=2,NM1	000200
L0177	25*	P(J)=U(J+1)-U(J)	000203
L0200	26*	PI=3.141592	000205
L0201	27*	AMW=ABS(W(I)-W(J))	000211
L0202	28*	APW=ABS(W(I)+W(J))	000215
L0203	29*	D(J)=(W(I)+W(J))*ALOC(APW))	000224
L0204	30*	IF(I-J)3,2,3	000227
L0207	31*	3 C(J)=(W(I)-W(J))*ALOC(APW))	000237
L0210	32*	THE SUB+=(1./PI)*P(J)*(C(J)+D(J))	000245
L0211	33*	GO TO 4	000247
L0212	34*	L THE SUB+=(1./PI)*P(J)*C(J)	000254
L0213	35*	4 THE TAA=THE TAA+THE SUB	000260
L0215	36*	THE TA(I)=THE TAA	000261
L0216	37*	RD=1.+R(I)-2.*SQRT(R(I))+COS(THETA(I))	000302
L0217	38*	G=(1.-R(I))*COS(PHI)/RD	000307
L0220	39*	PN=2.*SQRT(R(I))*SIN(THETA(I))*COS(PHI)/RD	000327
L0221	40*	RFS=((Q-SIN(PHI)*TAN(PHI))*2+PN**2)/((Q+SIN(PHI)*TAN(PHI))**2+1E4**2)	000327
L0221	41*	RS=2.*RC(I)/(1.+POL)+RFS*(1.-POL)	000343
L0222	42*	PG=Q**2-PN**2+(SIN(PHI))**2	000351
L0223	43*	ZN(I)=((PG+(PG**2+4.*PN*G)**2)**.5)/2.)**.5	000356
L0224	44*	ZK(I)=PN*G/ZN(I)	000402
L0225	45*	RNEW(I)=RS	000405
L0226	46*	IF(ITER-1)30,61,61	000407
L0227	47*	61 WRITE(6,50)ITER,X(I),RNEW(I),ZN(I),ZK(I)	000412
L0232	48*	50 FORMAT(5X,'M=',I3,10X,'X = ',F10.5,10X,'RNEW = ',F10.5,10X,'ZN = ',	000427
L0241	49*	\$F10.5,10X,'ZK = ',F10.5)	000427
L0241	50*	30 CONTINUE	000427
L0242	51*	IF(ITER-7)7L,71,72	000427
L0244	52*	72 IF(ITER-13)71,74,74	000433
L0247	53*	73 DO 20 II=2,NM1	000441
L0252	54*	74 IF(X(II)-10.09)41,41,42	000446
L0255	55*	41 R(II)=RNEW(II)	000451
L0260	56*	20 GO TO 26	000453
L0261	57*	42 IF(X(II)-15.01)43,44,44	000455
L0262	58*	43 R(II)=(RNEW(II)+R(II))/2.	000460
L0265	59*	26 GO TO 26	000464
L0266	60*	44 R(II)=RNEW(II)	000466
L0267	61*	26 CONTINUE	000471
L0270	62*	R(1)=R(2)	000471
L0272	63*	R(N)=R(NM1)	000473
L0273	64*	GO TO 33	000475
L0274	65*	71 DO 25 II=2,NM1	000477
L0275	66*	IF(Y(II)-10.19)51,51,52	000504
L0280	67*	51 F(II)=RNEW(II)	000507
L0303	68*	GO TO 25	000511
L0304	69*		

00305	70*	52 IF(X(II)=13.e1)53,54,54	000513
00310	71*	53 R(II)=(RNEW(II)+R(II))/2.	000516
00311	72*	GO TO 25	000522
00312	73*	54 R(II)=RNEW(II)	000524
00313	74*	25 CONTINUE	000527
00315	75*	R(1)=R(2)	000527
00316	76*	R(N)=R(N-1)	000531
00317	77*	GO TO 37	000533
00320	78*	74 DO 27 II=2,NM1	000535
00323	79*	IF(X(II)=10.29)56,56,57	000542
00326	80*	56 R(II)=RNEW(II)	000545
00327	81*	DO TO 27	000547
00331	82*	57 IF(X(II)=12.51)58,59,59	000551
00333	83*	58 R(II)=(RNEW(II)+R(II))/2.	000554
00334	84*	GO TO 27	000560
00335	85*	59 R(II)=RNEW(II)	000562
00336	86*	27 CONTINUE	000565
00340	87*	R(1)=R(2)	000565
00341	88*	R(N)=R(N-1)	000567
00342	89*	33 CONTINUE	000573
00344	90*	STOP	000573
00345	91*	END	000577

END OF COMPILED: NO DIAGNOSTICS.

		2.5000	2.2000	3.0000	3.5000	4.0000	4.5000	5.0000	5.5000
		8.0000	7.0000	7.5000	8.0000	8.2000	8.4000	8.6000	8.8000
		9.0000	9.2000	9.4000	9.6000	9.8000	9.9000	10.0000	10.1000
		10.2000	10.3000	10.4000	10.5000	10.6000	10.7000	10.8000	10.9000
		11.2000	11.4000	11.6000	12.0000	12.2000	12.4000	12.5000	12.6000
		12.7000	12.8000	12.9000	13.0000	13.1000	13.2000	13.3000	13.4000
		13.5000	13.6000	13.8000	14.0000	14.5000	15.0000	15.5000	16.0000
		16.5000	17.0000	17.5000	18.0000	.2282	.2282	.2259	.2242
		.2222	.2197	.2167	.2131	.2087	.1963	.1874	.1757
		.1648	.1632	.1554	.1463	.1353	.1219	.1049	.0823
		.0499	.0279	.0174	.0164	.0104	.0360	.0858	.0120
		.9278	.9304	.9450	.9556	.9613	.9647	.9666	.9659
		.7623	.9517	.9387	.0131	.7225	.0471	.5984	.5631
		.5358	.5138	.4926	.4823	.4671	.4556	.4366	.4214
		.3856	.3754	.3621	.3522	.3442	.3378	.3283	.3283
M = 1	x =	2.0000	RNEW =	.45595	ZN =	1.65797	ZK =	-.02534	
M = 1	y =	3.00000	RNEW =	.45124	ZN =	1.65001	ZY =	-.03255	
M = 1	x =	3.50000	RNEW =	.44774	ZN =	1.64409	Zk =	-.03778	
M = 1	x =	4.00000	RNEW =	.44361	ZN =	1.63710	ZK =	-.04352	
M = 1	x =	4.50000	RNEW =	.43945	ZN =	1.62845	ZK =	-.04926	
M = 1	x =	5.00000	RNEW =	.43225	ZN =	1.61910	ZY =	-.05556	
M = 1	x =	5.50000	RNEW =	.42479	ZN =	1.60576	ZK =	-.06211	
M = 1	x =	6.00000	RNEW =	.41566	ZN =	1.59796	ZK =	-.06811	
M = 1	x =	7.00000	RNEW =	.38974	ZN =	1.54884	ZK =	-.08710	
M = 1	x =	7.50000	RNEW =	.37111	ZN =	1.51989	ZK =	-.09478	
M = 1	x =	8.00000	RNEW =	.34651	ZN =	1.48209	ZK =	-.10473	
M = 1	x =	8.20000	RNEW =	.33412	ZN =	1.46779	ZY =	-.10749	
M = 1	x =	8.40000	RNEW =	.32024	ZN =	1.44341	ZK =	-.11061	
M = 1	y =	8.60000	RNEW =	.30325	ZN =	1.41979	ZK =	-.11335	
M = 1	x =	8.80000	RNEW =	.28476	ZN =	1.39279	ZK =	-.11556	
M = 1	y =	9.00000	RNEW =	.26175	ZN =	1.36102	ZK =	-.11675	
M = 1	x =	9.20000	RNEW =	.23387	ZN =	1.32354	ZK =	-.11627	
M = 1	x =	9.40000	RNEW =	.19285	ZN =	1.27909	ZK =	-.11252	
M = 1	x =	9.60000	RNEW =	.15311	ZN =	1.22107	ZK =	-.10266	
M = 1	x =	9.80000	RNEW =	.08957	ZN =	1.13987	ZK =	-.06597	
M = 1	x =	9.90000	RNEW =	.04849	ZN =	1.08882	ZK =	-.06382	
M = 1	x =	10.00000	RNEW =	.00781	ZN =	.99576	ZK =	-.03464	
M = 1	x =	10.10000	RNEW =	.22008	ZN =	.88359	ZK =	-.04380	
M = 1	x =	10.20000	RNEW =	.77335	ZN =	.78213	ZK =	-.03277	
M = 1	x =	10.30000	RNEW =	.58825	ZN =	.62567	ZK =	-.05321	
M = 1	x =	10.40000	RNEW =	.93366	ZN =	.40965	ZY =	-.09640	
M = 1	x =	10.50000	RNEW =	.95662	ZN =	.13996	ZK =	-.33410	
M = 1	x =	10.60000	RNEW =	.97029	ZN =	.08877	ZK =	-.61557	
M = 1	x =	10.70000	RNEW =	.97938	ZN =	.07750	ZK =	-.83087	
M = 1	x =	10.80000	RNEW =	.93581	ZN =	.07453	ZK =	-1.02300	
M = 1	x =	11.00000	RNEW =	.99437	ZN =	.07844	ZK =	-1.38934	
M = 1	x =	11.20000	RNEW =	.99974	ZN =	.09138	ZK =	-1.77736	
M = 1	x =	11.40000	RNEW =	1.00307	ZN =	.11525	ZK =	-2.22944	
M = 1	x =	11.60000	RNEW =	1.00681	ZN =	.15819	ZY =	-2.80717	
M = 1	x =	12.00000	RNEW =	1.01257	ZN =	.45779	ZK =	-4.98073	
M = 1	x =	12.20000	RNEW =	1.01616	ZN =	1.29560	ZK =	-8.02623	
M = 1	x =	12.40000	RNEW =	1.02213	ZN =	15.50962	ZK =	-19.63038	
M = 1	x =	12.50000	RNEW =	1.02940	ZN =	16.06409	ZK =	15.07663	
M = 1	x =	12.60000	RNEW =	1.04752	ZN =	4.66971	ZY =	6.39406	
M = 1	x =	12.70000	RNEW =	1.04320	ZN =	7.65975	ZK =	2.07209	
M = 1	y =	12.80000	RNEW =	1.03157	ZN =	7.42097	ZK =	1.99676	
M = 1	x =	12.90000	RNEW =	.98710	ZN =	7.23372	ZY =	1.50092	

M = 1	x = 13.0000	RNEW = .96062	ZN = 3.08307	ZK = 1.19783
M = 1	x = 13.1000	RNEW = .93652	ZN = 2.96100	ZK = .99258
M = 1	x = 13.2000	RNEW = .91480	ZN = 2.86767	ZK = .84403
M = 1	x = 13.3000	RNEW = .89526	ZN = 2.77707	ZK = .73147
M = 1	x = 13.4000	RNEW = .87772	ZN = 2.70569	ZK = .64368
M = 1	x = 13.5000	RNEW = .86176	ZN = 2.64567	ZK = .57301
M = 1	x = 13.6000	RNEW = .84726	ZN = 2.59335	ZK = .51428
M = 1	x = 13.7000	RNEW = .82199	ZN = 2.50577	ZK = .42667
M = 1	x = 14.0000	RNEW = .80065	ZN = 2.43612	ZK = .36319
M = 1	x = 14.5000	RNEW = .75295	ZN = 2.29469	ZK = .24103
M = 1	x = 15.0000	RNEW = .73056	ZN = 2.22730	ZK = .17175
M = 1	x = 15.5000	RNEW = .70858	ZN = 2.17876	ZK = .13130
M = 1	x = 16.0000	RNEW = .69147	ZN = 2.13551	ZK = .09782
M = 1	x = 16.5000	RNEW = .67207	ZN = 2.10245	ZK = .07094
M = 1	x = 17.0000	RNEW = .66677	ZN = 2.07541	ZK = .04795
M = 1	x = 17.9000	RNEW = .64957	ZN = 2.03521	ZK = .03423
M = 2	x = 2.2000	RNEW = .42654	ZN = 2.72767	ZK = -.01172
M = 2	x = 3.1000	RNEW = .42348	ZN = 2.68958	ZK = -.00627
M = 2	x = 3.5000	RNEW = .42119	ZN = 2.66686	ZK = -.00418
M = 2	x = 4.0000	RNEW = .41847	ZN = 2.64044	ZK = -.00305
M = 2	x = 4.5000	RNEW = .41501	ZN = 2.60794	ZK = -.00134
M = 2	x = 5.0000	RNEW = .41080	ZN = 2.56965	ZK = -.00047
M = 2	x = 5.5000	RNEW = .40564	ZN = 2.52472	ZK = .00119
M = 2	x = 6.0000	RNEW = .39919	ZN = 2.47133	ZK = .00653
M = 2	x = 7.0000	RNEW = .38019	ZN = 2.32962	ZK = -.00619
M = 2	x = 7.5000	RNEW = .36579	ZN = 2.23348	ZK = -.00430
M = 2	x = 8.0000	RNEW = .34594	ZN = 2.11622	ZK = -.01140
M = 2	x = 8.4000	RNEW = .33556	ZN = 2.06056	ZK = -.01116
M = 2	x = 8.4500	RNEW = .32306	ZN = 2.00062	ZK = -.01278
M = 2	x = 8.5000	RNEW = .30925	ZN = 1.93296	ZK = -.01513
M = 2	x = 8.8000	RNEW = .29198	ZN = 1.85806	ZK = -.01810
M = 2	x = 9.0000	RNEW = .27057	ZN = 1.77295	ZK = -.02181
M = 2	x = 9.2000	RNEW = .24366	ZN = 1.67564	ZK = -.02601
M = 2	x = 9.4000	RNEW = .20874	ZN = 1.56497	ZK = -.02972
M = 2	x = 9.6000	RNEW = .16158	ZN = 1.43233	ZK = -.03164
M = 2	x = 9.8000	RNEW = .09435	ZN = 1.26367	ZK = -.04430
M = 2	x = 9.9000	RNEW = .05065	ZN = 1.1t212	ZK = -.03614
M = 2	x = 10.0000	RNEW = .00796	ZN = 1.01134	ZK = -.04532
M = 2	x = 10.1000	RNEW = .22470	ZN = .96704	ZK = -.07838
M = 2	x = 10.2000	RNEW = .77614	ZN = .70281	ZK = -.05701
M = 2	x = 10.3000	RNEW = .89191	ZN = .39927	ZK = -.12495
M = 2	x = 10.4000	RNEW = .93327	ZN = .11936	ZK = -.47189
M = 2	x = 10.5000	RNEW = .95312	ZN = .08121	ZK = -.76726
M = 2	x = 10.6000	RNEW = .96408	ZN = .06891	ZK = -.99384
M = 2	x = 10.7000	RNEW = .97075	ZN = .06270	ZK = -1.19145
M = 2	x = 10.8000	RNEW = .97503	ZN = .05934	ZK = -1.37461
M = 2	x = 11.0000	RNEW = .97977	ZN = .05627	ZK = -1.72079
M = 2	x = 11.2000	RNEW = .98167	ZN = .05624	ZK = -2.06676
M = 2	y = 11.4000	RNEW = .98260	ZN = .05857	ZK = -2.43292
M = 2	x = 11.6000	RNEW = .98250	ZN = .06753	ZK = -2.94240
M = 2	x = 12.0000	RNEW = .97989	ZN = .09161	ZK = -3.94366
M = 2	x = 12.2000	RNEW = .97674	ZN = .13365	ZK = -4.82477
M = 2	x = 12.4000	RNEW = .96965	ZN = .27975	ZK = -6.40517
M = 2	x = 12.5000	RNEW = .96045	ZN = .65290	ZK = -8.09271
M = 2	x = 12.6000	RNEW = .92141	ZN = 3.06991	ZK = -11.11707
M = 2	x = 12.7000	RNEW = .85550	ZN = 8.74957	ZK = -7.96124
M = 2	x = 12.8000	RNEW = .82199	ZN = 8.49655	ZK = -4.46860

M= 39	X= 4.50000	RNEW= .41941	ZN= 2.49268	ZK= -.02693
M= 39	X= 5.00000	RNEW= .41460	ZN= 2.46538	ZK= -.02878
M= 39	X= 5.50000	RNEW= .40898	ZN= 2.43291	ZK= -.02994
M= 39	X= 6.00000	RNEW= .40193	ZN= 2.39376	ZK= -.02764
M= 39	X= 7.00000	RNEW= .38152	ZN= 2.28507	ZK= -.03891
M= 39	X= 7.50000	RNEW= .36642	ZN= 2.20965	ZK= -.03600
M= 39	X= 8.00000	RNEW= .34597	ZN= 2.11280	ZK= -.03839
M= 39	X= 8.20000	RNEW= .33541	ZN= 2.06548	ZK= -.03574
M= 39	X= 8.40000	RNEW= .32339	ZN= 2.01330	ZK= -.03413
M= 39	X= 8.60000	RNEW= .30593	ZN= 1.95297	ZK= -.03246
M= 39	X= 8.80000	RNEW= .29169	ZN= 1.88427	ZK= -.03056
M= 39	X= 9.00000	RNEW= .27038	ZN= 1.80388	ZK= -.02872
M= 39	X= 9.20000	RNEW= .24376	ZN= 1.70988	ZK= -.02677
M= 39	X= 9.40000	RNEW= .20913	ZN= 1.59704	ZK= -.02447
M= 39	X= 9.60000	RNEW= .16216	ZN= 1.45829	ZK= -.02204
M= 39	X= 9.80000	RNEW= .09480	ZN= 1.27856	ZY= -.03650
M= 39	X= 9.90000	RNEW= .05083	ZN= 1.16944	ZK= -.03080
M= 39	X= 10.00000	RNEW= .00796	ZN= 1.01199	ZK= -.04573
M= 39	X= 10.10000	RNEW= .22203	ZN= .86037	ZK= -.07995
M= 39	X= 10.20000	RNEW= .77031	ZN= .67862	ZK= -.05773
M= 39	X= 10.30000	RNEW= .88476	ZN= .31118	ZK= -.15100
M= 39	X= 10.40000	RNEW= .92634	ZN= .09151	ZK= -.57525
M= 39	X= 10.50000	RNEW= .94668	ZN= .06754	ZK= -.86850
M= 39	X= 10.60000	RNEW= .95568	ZN= .05948	ZK= -1.10378
M= 39	X= 10.70000	RNEW= .96627	ZN= .05605	ZK= -1.31424
M= 39	X= 10.80000	RNEW= .97146	ZN= .05489	ZK= -1.51300
M= 39	X= 11.00000	RNEW= .97792	ZN= .05651	ZK= -1.89808
M= 39	X= 11.20000	RNEW= .98160	ZN= .06220	ZK= -2.29439
M= 39	X= 11.40000	RNEW= .98280	ZN= .07229	ZK= -2.72666
M= 39	X= 11.60000	RNEW= .98511	ZN= .08865	ZK= -3.22607
M= 39	X= 12.00000	RNEW= .98543	ZN= .16394	ZK= -4.64876
M= 39	X= 12.20000	RNEW= .98415	ZN= .28938	ZK= -5.86438
M= 39	X= 12.40000	RNEW= .97989	ZN= .71742	ZK= -8.29227
M= 39	X= 12.50000	RNEW= .97335	ZN= 1.74080	ZK= -11.15841
M= 39	X= 12.60000	RNEW= .94111	ZN= 8.59705	ZK= -14.43840
M= 39	X= 12.70000	RNEW= .87067	ZN= 12.19541	ZK= -5.24964
M= 39	X= 12.80000	RNEW= .82721	ZN= 9.86012	ZK= -2.65879
M= 39	X= 12.90000	RNEW= .79646	ZN= 8.46125	ZK= -1.77450
M= 39	X= 13.00000	RNEW= .77263	ZN= 7.56868	ZK= -1.34203
M= 39	X= 13.10000	RNEW= .75320	ZN= 6.94576	ZK= -1.08846
M= 39	X= 13.20000	RNEW= .73684	ZN= 6.48278	ZK= -.92332
M= 39	X= 13.30000	RNEW= .72279	ZN= 6.12374	ZK= -.80900
M= 39	X= 13.40000	RNEW= .71750	ZN= 5.83784	ZK= -.72490
M= 39	X= 13.50000	RNEW= .69977	ZN= 5.60214	ZK= -.65998
M= 39	X= 13.60000	RNEW= .69010	ZN= 5.40407	ZK= -.61061
M= 39	X= 13.80000	RNEW= .67362	ZN= 5.09353	ZK= -.53087
M= 39	X= 14.00000	RNEW= .65994	ZN= 4.85817	ZK= -.47129
M= 39	X= 14.50000	RNEW= .62977	ZN= 4.38937	ZK= -.40695
M= 39	X= 15.00000	RNEW= .61553	ZN= 4.18899	ZK= -.40439
M= 39	X= 15.50000	RNEW= .60178	ZN= 4.01561	ZK= -.37028
M= 39	X= 16.00000	RNEW= .59102	ZN= 3.88530	ZK= -.35887
M= 39	X= 16.50000	RNEW= .58251	ZN= 3.78589	ZK= -.35599
M= 39	X= 17.00000	RNEW= .57539	ZN= 3.70460	ZK= -.35878
M= 39	X= 17.50000	RNEW= .56455	ZN= 3.57793	ZK= -.39656
M= 40	X= 2.20000	RNEW= .43257	ZN= 2.57114	ZK= -.02108
M= 40	X= 3.00000	RNEW= .42901	ZN= 2.54977	ZK= -.02197
M= 40	X= 3.50000	RNEW= .42630	ZN= 2.53403	ZK= -.02752

M= 40	X= 4.60000	RNEW= .42730	ZN= 2.51558	ZK= -.02545
M= 40	X= 4.50000	RNEW= .41941	ZN= 2.49268	ZK= -.02697
M= 40	X= 5.00000	RNEW= .41469	ZN= 2.46538	ZK= -.02886
M= 40	X= 5.50000	RNEW= .40898	ZN= 2.43292	ZK= -.02982
M= 40	X= 6.00000	RNEW= .40193	ZN= 2.39376	ZK= -.02784
M= 40	X= 7.00000	RNEW= .38152	ZN= 2.28507	ZK= -.03987
M= 40	X= 7.50000	RNEW= .36642	ZN= 2.20965	ZK= -.03604
M= 40	X= 8.00000	RNEW= .34597	ZN= 2.11260	ZK= -.03840
M= 40	X= 8.50000	RNEW= .33541	ZN= 2.06548	ZK= -.03567
M= 40	X= 8.40000	RNEW= .32330	ZN= 2.01330	ZK= -.03411
M= 40	X= 8.60000	RNEW= .30893	ZN= 1.95293	ZK= -.03247
M= 40	X= 8.80000	RNEW= .29169	ZN= 1.88427	ZK= -.03059
M= 40	X= 9.00000	RNEW= .27039	ZN= 1.80365	ZK= -.02873
M= 40	X= 9.20000	RNEW= .24376	ZN= 1.70988	ZK= -.02676
M= 40	X= 9.40000	RNEW= .20913	ZN= 1.59704	ZK= -.02447
M= 40	X= 9.60000	RNEW= .16216	ZN= 1.45829	ZK= -.02203
M= 40	X= 9.80000	RNEW= .09480	ZN= 1.27858	ZK= -.03650
M= 40	X= 9.90000	RNEW= .05083	ZN= 1.16945	ZK= -.03089
M= 40	X= 10.00000	RNEW= .00796	ZN= 1.01199	ZK= -.04573
M= 40	X= 10.10000	RNEW= .22202	ZN= .86037	ZK= -.07994
M= 40	X= 10.20000	RNEW= .77031	ZN= .67862	ZK= -.05773
M= 40	X= 10.30000	RNEW= .88476	ZN= .31120	ZK= -.15099
M= 40	X= 10.40000	RNEW= .92634	ZN= .09151	ZK= -.57523
M= 40	X= 10.50000	RNEW= .94628	ZN= .06754	ZK= -.86848
M= 40	X= 10.60000	RNEW= .95868	ZN= .05948	ZK= -.1.10350
M= 40	X= 10.70000	RNEW= .96627	ZN= .05605	ZK= -.1.31426
M= 40	X= 10.80000	RNEW= .97145	ZN= .05489	ZK= -.1.51295
M= 40	X= 11.00000	RNEW= .97792	ZN= .05651	ZK= -.1.89807
M= 40	X= 11.20000	RNEW= .98160	ZN= .06220	ZK= -.2.29434
M= 40	X= 11.40000	RNEW= .98380	ZN= .07229	ZK= -.2.72672
M= 40	X= 11.60000	RNEW= .98511	ZN= .08865	ZK= -.3.22610
M= 40	X= 12.00000	RNEW= .98543	ZN= .16893	ZK= -.4.64866
M= 40	X= 12.20000	RNEW= .98415	ZN= .28835	ZK= -.5.88399
M= 40	X= 12.40000	RNEW= .97989	ZN= .71735	ZK= -.8.29175
M= 40	X= 12.50000	RNEW= .97335	ZN= 1.74071	ZK= -.11.15813
M= 40	X= 12.60000	RNEW= .94111	ZN= 8.59324	ZK= -.14.43625
M= 40	X= 12.70000	RNEW= .87067	ZN= 12.19351	ZK= -.5.25138
M= 40	X= 12.80000	RNEW= .82721	ZN= 9.85938	ZK= -.2.66004
M= 40	X= 12.90000	RNEW= .79646	ZN= 8.46114	ZK= -.1.77478
M= 40	X= 13.00000	RNEW= .77263	ZN= 7.56850	ZK= -.1.34254
M= 40	X= 13.10000	RNEW= .75320	ZN= 6.94561	ZK= -.1.08887
M= 40	X= 13.20000	RNEW= .73684	ZN= 6.48271	ZK= -.92357
M= 40	X= 13.30000	RNEW= .72279	ZN= 6.12367	ZK= -.80922
M= 40	X= 13.40000	RNEW= .71059	ZN= 5.83784	ZK= -.72496
M= 40	X= 13.50000	RNEW= .69977	ZN= 5.60214	ZK= -.65999
M= 40	X= 13.60000	RNEW= .69010	ZN= 5.40403	ZK= -.61082
M= 40	X= 13.80000	RNEW= .67362	ZN= 5.09355	ZK= -.53079
M= 40	X= 14.00000	RNEW= .65994	ZN= 4.85819	ZK= -.47114
M= 40	X= 14.50000	RNEW= .62977	ZN= 4.38935	ZK= -.40701
M= 40	X= 15.00000	RNEW= .61553	ZN= 4.18900	ZK= -.40432
M= 40	X= 15.50000	RNEW= .60178	ZN= 4.01559	ZK= -.37035
M= 40	X= 16.00000	RNEW= .59102	ZN= 3.88528	ZK= -.35896
M= 40	X= 16.50000	RNEW= .58251	ZN= 3.78587	ZK= -.35607
M= 40	X= 17.00000	RNEW= .57539	ZN= 3.70466	ZK= -.35891
M= 40	X= 17.90000	RNEW= .56455	ZN= 3.57791	ZK= -.39650

6F02, ASL?

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לעתה נספחים למסמך פולני, מודע

CC03	1,137.4
CC04	6,133
CC05	1,132.6
CC06	412.13
CC07	910.05
CC08	53.77
CC09	41.00
CC10	7,757.8

ETRACE ASSIGNMENT EBLOCK, TYPE: RELATIVE LOCATION: NAME:

FFFF	514255 107	FFFF	514253F 1110	FFFF	514253 1153	FFFF	5142544 1240	FFFF	5142551 1260
F 51	514255 1170	FFFF	514251 1403	FFFF	5142511 1580	FFFF	5142533 1653	0001	000137 1710
FFFF	5142550 172	FFFF	514251 177	FFFF	514251 181	FFFF	514252 447	0000	514256 ECF
FFFF	5142552 1	FFFF	514244 AMW	FFFF	514245 AP4	FFFF	5142510 P	0000	514252 CFC
FFFF	5142553 2	FFFF	514247 77	FFFF	5142540 T	FFFF	514252 TT	0000	514242 J
FFFF	5142553 33	FFFF	514257 1Y	FFFF	514256 L	FFFF	514257 LM1	0000	514250 N
FFFF	5142554 111	FFFF	514251 F	FFFF	514252 FT	FFFF	5142510 F	0000	514255 U
FFFF	5142555 W	FFFF	514252 X	FFFF	514252 Y	FFFF	5142510 ZK	0000	514252 ZN
FFFF	5142556 NW	FFFF	514254F 279						

```

L0171    2*      D1=M1*Y10, A1=1.1, R1=PC1, C1=PC2, S1=PC3, P1=PC4, U1=PC5, W1=PC6
CL1P1    3*      -2N1*(PC1), P1*(ZL1)+S1*(ZC1)+Y1*(ZU1)
CO1P3    4*      RE=PC1, IM=PC2
CO1PF   5*      17 FORMAT(1E3)
FC1P7   6*      RE1=PC1, P1*(Y(K)), K=1+N1, (Z(K)), K=1+N1
FC1P11  6*      27 FORMAT(1E3,0)
CO1P8   7*      W1=PC1*(4.0)*(Y(K)), K=1+N1, (Z(K)), K=1+N1
CO1P4   8*      45 FORMAT(1E3, X*8, 1E3, 6, 2X)
LB1P5   9*      X=E, T
D01P6  10*      D0, P1, JU=1,N
DC1P41  11*      22 X(JU)=PC1*PC0, Y(JU)
CL14    12*      NM=N-1
DC1P48  13*      D0, P1, T=PC1*NM2
DC1P47  14*      P(T)=K(T)
DC1P1   15*      22 QM1=NM2
DC1P50  15*      P(1)=P(2)
DC1P52  17*      R(M)=P(M)*X1
DC1P54  17*      D0, P1, L=2,N
LC1P5   18*      LM1=LM-1
CO1P7   19*      A(L)=P(L)-R(L)*X1
CO1P1   21*      P(L)=X(L)-W(L)*X1
CL1P52  22*      S(L)=P(L)/P(0)

```

CCCCCFC
CCCCF
CCCCF1
CCCCF7
CCCCF7
CCCCF7
CCCC35
CCCC35
CCCCF4
CCCC54
CCCC56
CCCCF5
CCC07F
CCCC72
CCCCC
CCC1F
CCC1F
CCC1C
CCC1C
CCC111
CCC111
CCC115
CCC12C
CCC123

```

00171 27*      DO 71 150,NM1
00172 28*      ZNM1=0.
00173 29*      DO 4 JZ=1,NM1
00174 30*      F(J)=U(J+1)-U(J)
00175 31*      P=1.157452
00176 32*      AMW=ACB*(X(J)-W(J))
00177 33*      AMV=ACB*(X(J)+W(J))
00178 34*      P(J)=(W(J)+k(J))*((AL-B(PW)))
00179 35*      T=(J-J0)*2.*7
00180 36*      P(J)=(W(J)-W(J0)*(AL-B(PW)))
00181 37*      ZNM2=(C./P1)*(J-J)*(P(J)+B(J))
00182 38*      GO TO 4
00183 39*      P(ZNM2)=(1./P1)*P(J)*(P(J))
00184 40*      R=NM2*NM2+ZNM2
00185 41*      TN(J)=TNV
00186 42*      G1=GGCT(X)
00187 43*      G2=G2CT(Z)
00188 44*      W=T-(G1*Y(T),Z*W(T)+X(Z))
00189 45*      FORMAT(1QX*Y(T)E15.7+1QX*Z(W(T))E15.7+1QX*W(K(T))E15.7)
00190 46*      GO TO 105
00191 47*      STOP
00192 48*      END

```

FFFF133
FFFF133
FFFF137
FFFF137
FFFF142
FFFF144
FFFF14C
FFFF154
FFFF153
FFFF1FF
FFFF1FF
CCCC204
CCCC20E
CCCC217
CCCC217
CCCC22F
CCCC22F
CCCC224
CCCC23E
CCCC23F
CCCC236
CCCC242

NO. OF C-47'S LAID DOWN NO. OF ADDED.

EMAP, EG
MAP 2221-A 7-11-8 146157473 1 117128
AFOM STATUS OF 5000 FT ELEVATION UNKNOWN

SYS-APLT-03-464-L-7773-7

ENR NOV. 21/28 1988 • 17

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4.400000 4.400000 5.000000 5.000000 5.500000 5.500000 6.000000 6.000000

2.1600000 2.0000000 1.8800000 1.7700000 1.6700000 15.4600000 10.5000000 10.5000000

11.300000 11.300000 11.300000 11.300000 11.300000 11.300000


```
8MFORLIB.MFOR,IS MAIN
FORTRAN-MACC 1.14S-05/27/70-13:41:10 (.0)      MAIN
00101    1.      DIMENSION R(20),W(20)
00102    2.      EXTERNAL F
00103    3.      COMMON Y1,Z1,Y2,Z2
00104    4.      T READ(5,7,END=100)WA
00107    5.      7 FORMAT(F5.2)
00110    6.      READ(5,9,END=100)Y2,Z2,Y1,Z1
00116    7.      9 FORMAT(4F10.7)
00117    8.      L=0
00120    9.      CALL NTQUAD(D,0+1.570795,F,2D,R,W,L,V,DUM)
00121   10.      VALUE=1.-V
00122   11.      PRINT 700,WA,V,VALUE
00127   12.      700 FORMAT(5X,'WA=',F5.2,24H SPECTRAL HEMI. EMIT=,E17.7,74H SPEC
00127   13.      $TRAL HEMI. REF.=,E17.7)
00130   14.      GO TO 3
00131   15.      100 STOP
00132   16.      END
```

END OF COMPIALATION: NO DIAGNOSTICS.

```

@MFOR=LIB.MFOR,IS F
FORTRAN-MACC 1.14S-C5/22/79-13:41:13 (,C1      F
00101   1.      FUNCTION F(X)
00102   2.      COMMON Y1,Z1,Y2,Z2
00103   3.      C=(Y1*Y2+Z1*Z2)/(Y2**2+Z2**2)*SIN(X)
00104   4.      H=(Y1*Z2-Y2*Z1)/(Y2**2+Z2**2)*SIN(X)
00105   5.      SS=1.-C**2+H**2
00106   6.      TT=C**2+H**2
00107   7.      R=(SS**2+TT**2)**0.5
00110   8.      Y=ATAN(-TT/SS)
00111   9.      C=Y1*COS(X)
00112  10.      D=(Y2*COS(Y/2.)+Z2*SIN(Y/2.))*R**0.5
00113  11.      P=Z1*COS(X)
00114  12.      Q=(Z2*COS(Y/2.)-Y2*SIN(Y/2.))*R**0.5
00115  13.      S=(C+D1)**2+(P+Q)**2
00116  14.      T=C**2-D**2+P**2-Q**2
00117  15.      U=2.*P*D-2.*C*Q
00120  16.      R01=(T/S)**2+(U/S)**2
00121  17.      C1=Y2*COS(X)
00122  18.      D1=(Y1*COS(Y/2.)+Z1*SIN(Y/2.))*R**0.5
00123  19.      P1=Z2*COS(X)
00124  20.      S1=(Z1*COS(Y/2.)-Y1*SIN(Y/2.))*R**0.5
00125  21.      S1=(D1+C1)**2+(P1+Q1)**2
00126  22.      T1=D1**2-C1**2+Q1**2-P1**2
00127  23.      U1=2.*Q1*C1-2.*P1*D1
00130  24.      R02=(T1/S1)**2+(U1/S1)**2
00131  25.      R0=0.5*(R02+R01)
00132  26.      E=1.-R0
00133  27.      F=2.*SIN(X)*COS(Y)
00134  28.      RETURN
00135  29.      END

```

END OF COMPILEATION: NO DIAGNOSTICS.

```

@MFOR+LIB.MFOR,IS MAIN
FORTRAN-MACC 1.14S-1.9/14/70-15:34:44 (P)          MAIN
00101      1.      DT=MNSTNN F0(44),Y1(44),E0(44),TC(43),F0(44),D(20),W(20),PLAND(44)
00102      2.      EXTERNAL F,FF
00103      3.      COMMON YY,YZ,TT
00104      4.      READ(S,16)(FC(I),I=1,44),(Y1(J),J=1,44)
00105      5.      10 FORMAT(I)
00106      6.      DO 5 I=1,44
00107      6.      TE(I)=1200.+100.*FL^AT(T-1)
00108      7.      TT=TE(T)
00109      8.      V1=0.
00110      9.      PLAN=0.
00111     10.      DC ? J=1,27
00112     11.      H=(1.5-0.2)/20.
00113     12.      Y=0.2+H*FLOAT(J-1)
00114     13.      C1=(6.E25E-1)*((3.E14)**2
00115     14.      C2=(6.E25E-1)*(3.E14)/(1.78E-2)
00116     15.      C3=C2/(Y1(J)*Y*TT)
00117     16.      IF(C3.GT. 85.6)GO TO 2
00118     17.      EX=EXP(C3)-1.
00119     18.      EA=2.*3.141592*C1/(Y1(J)**2+Y**5+Y)
00120     19.      PLAND(J)=EA
00121     20.      PLAN=PLAN+PLAND(J)
00122     21.      EB(J)=EA
00123     22.      V1=V1+H*FO(J)*E0(J)
00124     23.      2 CONTINUE
00125     24.      PLAN=4*(PLAN-L.E+PLAND(1)-L.5*PLAND(27))
00126     25.      V1=V1-0.5*H*(E0(1)+EB(1)+E0(27)+EB(27))
00127     26.      V2=0.
00128     27.      PLA=0.
00129     28.      DO 3 J=27,44
00130     29.      S=(10.-1.5)/17.
00131     30.      X=1.5+C*FLOAT(J-27)
00132     31.      D1=(6.E25E-1)*((3.E14)**2
00133     32.      D2=(6.E25E-1)*(3.E14)/(1.38E-8)
00134     33.      D3=D2/(Y1(J)*X*TT)
00135     34.      IF(D3.GT. 85.6)GO TO 3
00136     35.      FX=EXP(D3)-1.
00137     36.      FA=2.*3.141592*D1/(Y1(J)**2+X**5+FX)
00138     37.      PLAND(J)=FA
00139     38.      PLA=PLA+PLAND(J)
00140     39.      EB(J)=FA
00141     40.      V2=V2+C*E0(J)*FB(J)
00142     41.      2 CONTINUE
00143     42.      PLA=C*(PLA-0.5*PLAND(27)-0.5*PLAND(44))
00144     43.      PLAN=PLAN+PLA
00145     44.      V2=V2-D.5*G*(E0(27)+E0(27)+E0(44)+FB(44))
00200     45.      YY=Y1(1)
00201     46.      YY=Y1(44)
00202     47.      L=0
00203     48.      CALL NTQUAD(0,M+0.2,F,20,R,W,L,V,DUM)
00204     49.      V3=E0(1)*V
00205     50.      PLANE=PLAN+V
00206     51.      L=0
00207     52.      CALL NTQUAD(10.,150.*FF+20,R,W,L,V,DUM)
00210     53.      V4=E0(44)*V
00211     54.      PLANE=PLAN+V
00212     55.

```

```
00213 56.      VALUE=(V1+V2+V3+V4)/PLSN
00214 57.      VAL=1.-VALUE
00215 58.      WRITE(1,2L)TT,VALUE,VAL
00222 59.      2F FORMAT(FX,'TL= ',F6.1,FX,'TOTAL HEM. EMISSION= ',E15.7,E5X,
00227 60.      S'TOTAL HEM. REFLECTANCE= ',F15.7)
00223 61.      Y1(1)=YY
00224 62.      Y1(44)=YZ
00225 63.      F CONTINUE
00227 64.      STOP
00230 65.      END
```

END OF COMPILEATION: NO DIAGNOSTICS.

```
8MF0R+LIB.MFCP,IS F
FCRTRAN-MACC 1.145-09/14/70-15:34:50 (+6)      F
00101    1.      FUNCTION F(X)
00102    2.      COMMON YY,Y7,TT
00103    3.      C1=(5.625E-1)*((3.514)**2
00104    4.      C2=(6.625E-1)*((3.514)/((1.7-E-F))
00105    5.      IF(X.LT.0.0001)GO TO 1
00106    6.      C7=C2/(YY*X*TT)
00107    7.      IF(C3.GT. .9E-16)GO TO 8
00108    8.      GO TO 9
00109    9.      IF(C3.LT.1.0E-10)GO TO 1
00110   10.      EX= EXP(C3)-1.
00111   11.      EA=7.*7.141592*C1/(YY**2*X**5.0*Y)
00112   12.      F=EA
00113   13.      GO TO 7
00114   14.      F=F*F.
00115   15.      7 RETURN
00116   16.      END
```

END OF COMPILED: NO DIAGNOSTICS.

6MFOR*LIB.MFOR,ASTLZ FF
FORTRAN-MACC 1.14S-19/14/79-15:25:05 (1,0) FF

FUNCTION FF ENTRY POINT 00P064

STORAGE USED:

0 DATA 000022
1 CODE 000074

COMMON BLOCKS:

2 BLANKS 000003

EXTERNAL REFERENCES:

3 EXP
4 NERR3\$

STORAGE ASSIGNMENT:

1 D0LG53 FL	1 D00CS4 7L	1 DPLD23 RBL	0 R C00R01 C1	0 R C00C02 C2
0 R D0G003 C7	0 R C00GS EA	0 R D0L004 EX	0 R D0UFCU FF	0 C C00C15 INJPS
2 R D0G002 TT	2 D0L000 YY	2 R D0UIC1 Y2		

00101	1.	FUNCTION FF(X)
00102	2.	COMMON YY,YZ,TT
00103	3.	C1=(F.E25E-19)*(3.E14)**2
00104	4.	C2=(E.625F-19)*(3.E14)/(1.32E-8)
00105	5.	IF(X.LT.0.D0L01)GO TO 1
00107	6.	C3=TT/(YZ*X*TT)
00110	7.	IF(C7.CT. 85.D150 GO TO 0
00112	8.	GO TO 90
00113	9.	IF(C7.LT.1.0E-10)GO TO 0
00115	10.	EX=EXP(C3)-1.
00116	11.	E4=2.*3.141592*C1/(YZ**2*X**5*EX)
00117	12.	FF=EA
00120	13.	CC TO 7
00121	14.	F FF=0.
00122	15.	7 RETURN
00123	16.	END

END OF COMPILEATION: NO DIAGNOSTICS.

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